

ORIGINATING REGISTERS SD-26040-01 AND SD-25551-01
DIAL PULSE OR "TOUCH-TONE®" CALLING
TESTS USING TEST SET SD-25676-01 (J24756B)
NO. 5 CROSSBAR OFFICES

1. GENERAL

PAGE

1.01 This section describes a method of testing nonwire-spring-relay type and wire-spring-relay type dial pulse or TOUCH-TONE calling originating register circuits in No. 5 crossbar offices using the test set circuit for register and CAMA sender circuits (test set) and the master test frame (MTF).

C. Preliminary Pulse—Register not Arranged for Centrex: This test checks the ability of the originating register to absorb one preliminary pulse.

17

1.02 The reasons for reissuing this section are listed below. Revision arrows are used to emphasize the more significant changes. Equipment Test Lists are affected.

D. Manual Call—Coin or Noncoin: This test checks the ability of the originating register to recognize a call from a manual line and to treat the call as a call to zero operator.

17

(a) To add test BC.

E. 11 Prefix Foreign Area Directing Code: This test checks the ability of the originating register to operate correctly when 11 prefixes a foreign area customer number.

18

(b) To make minor changes as required.

1.03 The tests covered are:

PAGE

A. Regular Call: This test checks the ability of the originating register to receive and record dial pulses or TOUCH-TONE pulses from a noncoin or coin customer and, together with the information received on the dial tone connection, to select and transmit to a marker at the end of dialing all information necessary for the satisfactory completion of a call on an AMA or non-AMA basis.

16

F. 11X Service Codes: This test checks the ability of the originating register to operate correctly when 11X service code is used.

18

B. Marker Coin Return: This test checks the ability of the originating register, when it is arranged for marker coin return, to return a coin when a coin-return signal is received from the marker.

16

G. X11 Service Codes and DDD Information Codes: This test checks the ability of the originating register to operate correctly when an X11 service code or a DDD information code is used.

19

H. Prefix Digit 1: This test checks the ability of the originating register to record digit 1 and correctly operate when a prefix digit 1 code is used.

19

I. Abandoned Call—Coin, Noncoin, DDD, or Centrex: This test checks the ability of the originating

NOTICE

Not for use or disclosure outside the Bell System except under written agreement

	PAGE		PAGE
register to release on an abandoned call. If the register is arranged for coin service, the test also checks that the register coin return circuit functions properly.	20	This test also checks that the originating register will recognize invalid combinations and sequences on 011+ IDDD calls and will return overflow tone to the calling customer.	24
J. Abandoned Call During Coin Test: This test checks the ability of the originating register, when it is arranged to check for the presence of a coin on lines not arranged for coin service improvement, to release on an abandoned call during coin test.	21	O. A_Digit Translation: This test checks the ability of the originating register to determine from the A digit dialed, the number of digits to be expected. It also checks the ability of the originating register to terminate the call after one digit when unused A digits are dialed.	25
K. Two-Party Test: This test checks the originating register 2-party test features on a 2-party, noncoin class of service that requires party test.	21	P. Combination A_ and B_Digit Translation: This test checks the ability of the originating register to determine, from the combination of A and B digits dialed, the number of digits to be received.	25
L. Start Pulse Signal: This test checks the ability of the originating register to reverse tip and ring to centrex attendants or tie line circuits.	22	Q. Pretranslation (Pretranslator SD-25568-01 Provided): This test checks the ability of the originating register to receive signals from a pretranslator which indicates to the register the number of digits to expect. It also checks that the originating register recognizes completion of dialing when that number of digits is received.	25
M. Zero Operator: The following features are checked. (1) The ability of the originating register to recognize a zero operator call. (2) If the register is arranged for a coin class that makes a coin clearance test after coin return, that the register recognizes that the coin has been returned. (3) The timed interval that the register will wait for additional digits is arranged for prefix digit 0 dialing.	22	Q.1 Pretranslation for IDDD (SD-27849-01 Provided): This test checks the ability of the originating register to receive signals from a pretranslator which indicates to the register the number of digits to expect. It also checks that the originating register recognizes completion of dialing when that number of digits is received.	26
N. Prefix Digits 0+: This test checks the ability of the originating register to operate correctly when a prefix digit 0 plus additional digits are dialed.	23	R. Stuck Coin: This test checks the ability of the originating register, when it is arranged to make coin clearance tests, to detect a stuck coin.	26
N.1 Prefix Digit 01+: This test checks the ability of the originating register to operate correctly when prefix digits 01 plus additional digits are dialed.	24	S. Straightforward Call to Manual Office: This test checks the ability of the originating register, when arranged to use a 1-, 2-, or 3-digit translator for a single office code, to function properly	
N.2 Prefix Digits 011+: This test checks the ability of the originating register to operate correctly when prefix digits 011 plus additional digits are dialed.			

PAGE	PAGE
when handling a call on a straightforward basis to a manual office.	27
T. Permanent Signal Timing—Coin or Noncoin: This test checks the ability of the originating register permanent signal timing circuit to function if the first digit is not dialed in the allotted time. If the originating register is arranged for coin service, it also checks that the coin return circuit of the register functions properly.	27
U. Partial Dial Timing—Coin, Noncoin, or Overload Condition: This test checks the ability of the originating register partial dial timing circuit to function if a digit is not dialed in the allotted time. If the originating register is arranged for coin service, it also checks that the coin return circuit of the register functions properly. If the originating register is arranged for 011+ (IDDD), it also checks that the register will time out when a sufficient number of digits are not used.	29
V. Register Timeout After Marker Sets Busy Tone: This test checks the ability of the originating register to time out after marker seizure within the allotted time.	30
W. Tip Party—Manual Test: This test checks the ability of the TP relay in the originating register to operate over the register-operate current flow test path. If the TP relay fails to operate, the test also checks that the originating register is held off-normal.	31
X. Timing During Pretranslation: This test checks that, from the time the originating register calls for a pretranslator until pretranslation is completed, the partial dial timing interval is not reduced.	31
Y. Timing During Coin Test—Dial-Tone-First: This test checks the ability of the originating register, when it is arranged for dial-tone-first, but	
not coin service improvement to detect the absence of a coin, transmit no-such-number tone, and release after the proper time interval.	32
Z. Common Alarm Timing: This test checks the ability of the originating register to cause the common alarm circuit to function properly in the allotted time.	33
AA. Recycle of Timing: This test checks the ability of the originating register to recycle its timing circuit when the function which is being timed is completed in the allotted time interval.	33
AB. Dial Tone Removal: This test checks that the register will properly remove dial tone upon receipt of one or more digits.	35
AC. Line Location, Class of Service, Observed Call, Storing, and Verification of Trouble Recorder Leads: This test checks the ability of the originating register to receive line location, class of service, and observe call information from a dial tone or combined marker and to transmit the information to a completing or combined marker. It also checks that the trouble recorder receives the proper identifying information from the originating register marker connector when the trouble recorder is seized by the marker.	36
AD. Precision Pulsing Test (3A Pulse Generating Test Set): This test checks the pulse-counting feature under marginal conditions.	36
AD.1 Precision Pulsing Test (4A Signaling Test Set): This test checks the pulse-counting feature under marginal conditions.	37
AE. Intracentrex Call: This test checks the ability of the originating register, when arranged for centrex	

	PAGE		PAGE
service, to function properly when handling an intra-PBX call.	38	which are a valid combination of TOUCH-TONE frequencies, and the third a signal of 2000 hertz at a higher level.	42
AF. 11X Special Codes—(Nonservice Codes) Originating Register Equipped for Centrex Service Only: This test checks the ability of the originating register, when arranged for PBX and not centrex service, to function properly when 11X code is dialed.	39	AN. Regular Precision Pulsing Test—TOUCH-TONE Calling (3A Pulse Generating Test Set): This test checks the ability of the originating register to receive and record TOUCH-TONE signals at nominal level (40-milliseconds pulse with 50 milliseconds between pulses) and frequencies at a fast signaling speed.	42
AG. Zero Operator Calls for Centrex Service: This test checks the ability of the originating register, when arranged for centrex service, to recognize an attendant call.	39	AN. 1 Regular Precision Pulsing Test—TOUCH-TONE Calling (4A Signaling Test Set): This test checks the ability of the originating register to receive and record TOUCH-TONE signals at nominal level (40-milliseconds pulse with 50 milliseconds between pulses) and frequencies at a fast signaling speed.	43
AH. 1XX Special Codes for Centrex Service: This test checks the ability of the originating register, when arranged for centrex service, to function properly when a 1XX code is dialed.	39	AO. Low-Level Precision Pulsing Test (3A Pulse Generating Test Set): This test checks the ability of the originating register to receive and record TOUCH-TONE signals at fast signaling speed when the signal level is lower than nominal.	44
AI. Deleted. (Refer to Test A)		AO. 1 Low-Level Precision Pulsing Test (4A Signaling Test Set): This test checks the ability of the originating register to receive and record TOUCH-TONE signals at fast signaling speed when the signal level is lower than nominal.	45
AJ. Low- and High-Level Signal Test: This test checks the ability of the originating register, when arranged for TOUCH-TONE calling, to properly receive and record digits when the signal level is lower or higher than nominal.	40	AP. Maximum and Minimum Frequency Precision Pulsing Test (3A Pulse Generating Test Set): This test checks that the originating register will correctly receive and record TOUCH-TONE signals at fast pulsing speeds when the signal level is lower than nominal and the signal frequencies are 1.5 percent higher or lower than nominal.	46
AK. Maximum and Minimum Frequency Test: This test checks the ability of the originating register, when arranged for TOUCH-TONE calling, to function properly when the TOUCH-TONE frequencies are 1.5 percent higher or lower than nominal.	41		
AL. Single-Frequency Test: This test checks the ability of the originating register to disregard TOUCH-TONE signals composed of a single frequency.	41		
AM. Special Three-Frequency Test: This test checks the ability of the originating register to disregard signals composed of three frequencies, two of			

PAGE	PAGE
<p>AP. 1 Maximum and Minimum Frequency Precision Pulsing Test (4A Signaling Test Set): This test checks that the originating register will correctly receive and record TOUCH-TONE signals at fast pulsing speeds when the signal level is lower than nominal and the signal frequencies are 1.5 percent higher or lower than nominal.</p>	<p>information call when a NN0 code is dialed. 52</p>
<p>AQ. Long Pulse Precision Pulsing Test (3A Pulse Generating Test Set): This test checks the ability of the originating register to receive and record TOUCH-TONE signals composed of a 50-millisecond pulse with an interval between pulses of 40 milliseconds.</p>	<p>AU. Range Extension for Unigauged Cabling: This test checks the ability of the originating register to switch the voltage on the L relay to -72 volts on calls originated by lines arranged for range extension. 53</p>
<p>AQ. 1 Long Pulse Precision Pulsing Test (4A Signaling Test Set): This test checks the ability of the originating register to receive and record TOUCH-TONE signals composed of a 50-millisecond pulse with an interval between pulses of 40 milliseconds.</p>	<p>AV. Unused Frequency Combinations: This test checks that an overflow tone is returned by the originating register upon receipt of an unused frequency combination generated from a 12- or 16-button TOUCH-TONE telephone set. 53</p>
<p>AR. CCSA CALL—Prefix Digit 8: This test checks the ability of the originating register, when arranged for centrex features, to receive a prefix digit 8 and indicate to the marker that the call is for a common control switching arrangement (CCSA) network. This test also checks that digit 1s immediately following a digit 8 prefix will be absorbed by the register.</p>	<p>AW. B₋ Digit Translation: This test checks the ability of the register to determine, from the B₋ digit dialed, the number of digits to be expected. It also checks the ability of the register to determine that only two digits are to be registered for unused B₋ digits. 54</p>
<p>AS. Interchangeable Codes and/or NPA-411 Information Codes: This test checks the ability of the originating register, when pretranslators are provided, to operate correctly when an interchangeable code or NPA-411 information code is dialed (refer to 1.05).</p>	<p>AX. CCSA Call—Access Digit 8: This test checks that the register will recognize that an access digit 8 was dialed to reach the No. 5 crossbar office. 54</p>
<p>AT. C₋ Digit Translation: This test checks the ability of the originating register to recognize that a call is either a DDD call or an NPA</p>	<p>AY. Toll Diversion: This test checks the ability of the register to recognize a signal from the marker that a call from a PBX trunk requires toll diversion, to reverse tip and ring to the PBX trunk, and to release if the customer goes on-hook at any time after the completion of the dialing. 55</p>
<p>48</p>	<p>AZ. Wideband Service: This test checks that an originating register arranged for wideband service will accept properly dialed wideband calls from PBX or non-PBX customers and will cause overflow tone to be returned on improperly dialed wideband calls. 55</p>
<p>49</p>	<p>BA. No Coin Present: This test checks that on a coin class-of-service call, when the register is arranged for</p>
<p>50</p>	
<p>51</p>	
<p>51</p>	

PAGE

◆ **coin service improvement (dial-tone-first)**◆ an SCN mark is passed to the marker when no coin is present. 56

BB. Lead Tests Between Originating Registers and Completing Markers: This test checks the NOB, OBS, LLO, 1, 2, 4 and 7 leads between the originating register and the completing markers. 56

BC. ◆ Digit 8 Access Call to Enhanced Private Communications System (EPSCS) No. 1 ESS: This test checks that the register will recognize that an access digit 8 was dialed to reach the EPSCS No. 1 ESS office.◆ 57

1.04 Test Charts are provided which show priming information required for Tests A through V, X, AA through BA. Spaces are provided on the charts for listing specific priming information depending on local conditions. These charts should be filled out from local records in accordance with the instructions provided in Part 5, Preparation of Test Chart.

1.05 An interchangeable code is a code that represents both a working office code in the home area and a working foreign area code. In some offices where interchangeable codes are provided, timing after the 7th digit is not required on toll calls. Therefore, a prefix digit of 0 or 1 must be dialed as an indication to the originating register (OR) that 10 digits are required to complete the call. In other offices a prefix digit of 0 may indicate to the OR that 7 or 10 digits may be dialed. These offices require timing after the 7th digit. A prefix digit of 1 indicates that the call requires 10 digits for completion. In either type of office if no prefix digit is dialed, the OR can expect 7 digits or in some cases less than 7 digits. Where pretranslators are provided, the dialing of an interchangeable code will result in the pretranslator grounding the CMB lead to the originating register.

1.06 If the office is equipped with both automatic monitor and circuit and test set circuit for register and CAMA sender circuits and the STT-STM key of the automatic monitor is operated while a

test is being made using the test set, the circuit will release as if the RL key had been operated.

1.07 Test I requires verifications at the traffic register cabinet. While performing Test I, the traffic register associated with the APD lead will operate once for each abandoned regular call. The traffic registers associated with the APD and FAPD leads will operate once for each abandoned DDD call. The reporting of these register operations should be in accordance with local instructions.

1.08 When the register is arranged for coin-first ground-start and coin service improvement (dial-tone-first), the coin features will be tested as coin service improvement (dial-tone-first).

1.09 In marker groups with four, five, or six dial tone markers, markers 0 and 1 will always have full access to all line link frames, trunk link frames and associated originating registers. In marker groups with five dial tone markers, markers other than 0 and 1 may have full or limited (graded) access to line link and trunk link frames and associated originating registers. In marker groups with six dial tone markers, markers other than 0 and 1 have only limited access to line link and trunk link frames and associated originating registers. It may be desirable to test a particular originating register with a particular marker, where limited access is provided, therefore the no-test (NT) connector should be used when selecting a line location appropriate for the required association between the particular marker and originating register group. The association of dial tone markers having limited access to certain frames shall be determined from office records.

1.10 Lettered Steps: A letter a, b, c, etc, added to a step number in Part 4 of this section indicates an action which may or may not be required depending on local conditions. The condition under which a lettered step or a series of lettered steps should be made is given in the ACTION column, and all steps governed by the same condition are designated by the same letter within a test. Where a condition does not apply, all steps designated by that letter should be omitted.

1.11 The manner of selecting some circuits and test conditions at the MTF and its associated circuits varies depending on the apparatus options furnished with these circuits. Therefore, where variable means of selection are provided, precise

instructions for the selection of circuits and test conditions are not given. Precise instructions for the use of these variable means are given in Section 218-106-301.

1.12 The location statement, At MTF—, is used to refer to all apparatus located on the four basic bays of the MTF.

1.13 On Issue 76D of SD-25800-01, a group of 18 "class of test" lamps was replaced by a single "start test" lamp designated STT. Since the designation given to the lamp is not specific, the lamp will not be called out in the section, as well as the 18 discontinued lamps such as DT, ORIG, ITDO, ITNP, OGT, etc.

2. APPARATUS

All Tests Except W

2.01 Master test control circuit, SD-25800-01.

2.02 Trunk test circuit, SD-25918-01.

2.03 Test circuit for register and CAMA sender circuits, SD-25988-01.

2.04 Test set circuit for register and CAMA sender circuits (test set), SD-25676-01.

2.05 Testing cord, 20-conductor cord, 6 feet long, equipped with one KS-13875 plug and one KS-13895 plug (W20C cord) (for connecting the test set to the test circuit for register and CAMA sender circuits).

2.06 Two patching cords, P3K cord, 6 feet long, equipped with two 310 plugs (3P15A cord) for patching ORT and RC jacks).

2.07 1014A dial hand test set (handset) or equivalent, equipped with a 2W38A cord assembly consisting of W2CK cord, 310 plug, and 471A jack (to listen for dial and busy tones).

2.08 Patching cord, P3D cord, 8 feet long, equipped with two 309 plugs (3P3B cord).

Tests J, T, U, W, X, Y, AA, BB

2.09 Blocking and insulating tools as required. Use tools and apply as covered in Section 069-020-801.

Tests M, T Through V, X Through AA, AH, AS

2.10 KS-3008 stopwatch or equivalent.

Tests J, W, X, Z Through AC, BB

2.11 322A (make-busy) plugs as required.

Tests AD, AN Through AQ, AD.1, AN.1 Through AQ.1

2.12 Patching cord, P3E cord, 8 feet long, equipped with two 310 plugs (3P6E cord) for connecting test circuit for register and CAMA sender circuit to 3A pulse generating test set or 4A signaling test set.

Tests AD, AN Through AQ, BB

2.13 3A pulse generating test set J94732A, 3A digit control test set and power supply unit J94732B (SD-95686-01).

Tests AD.1, AN.1 Through AQ.1, BB

2.14 4A signaling test set J94743A and loop unit J9473AB (SD-1C244-01)

Test AY

2.15 Patching cord, P3F cord, 4 feet long, equipped with one 309 plug and one 310 plug (3P12A cord).

3. PREPARATION

3.01 Under nonoverload condition, begin dialing or keying digits shown on Test Chart within 20 seconds after operating STT key or the register may time out. Under overload condition, begin dialing or keying digits shown on Test Chart within 10 seconds after operating STT key or register may time out.

SECTION 218-135-503

3. PREPARATION (Cont)

Note: Refer to 1.05, 1.06, 1.09, 1.11, and 1.12.

STEP	ACTION	TEST															
		A	B	C	D	E	F	G	H	I	J	K	L	M	N	N.1	N.2
1	At MTF — Restore all keys and switches.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
2	Momentarily operate RL key.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
3	Select dial tone marker having access to originating register under test (refer to 1.09).	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
4	Select OR class of test.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
5	Select route advance 0.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
6	Select originating register group.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
7	Select originating register to be tested.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
8	Operate TRR key.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
9	Operate FS, TS keys.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
10	Patch RC jack on test set to RC jack on MTF or to RC jack on originating register frame.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
11a	If performing dial pulsing tests — Patch ORT jack on test set to ORT jack on MTF or to ORT jack on originating register frame.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
12a	Patch handset to PLS jack of test set.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X
13b	If performing TOUCH-TONE dialing tests — Patch IRT connector on test set to IRT jack on MTF or to IRT jack on originating register frame.	X		X		X	X	X	X					X	X	X	X
14b	Patch handset to ORT jack of test set.	X		X		X	X	X	X					X	X	X	X

3. PREPARATION

Note: Refer to 1.05, 1.06, 1.09, 1.11, and 1.12.

STEP	ACTION	TEST																
		A	B	C	D	E	F	G	H	I	J	K	L	M	N	N.1	N.2	
15	Prepare 3A pulse generating test set as outlined in the section titled 3A Pulse Generating Test Set Description and Operation.																	
16	Patch PLS jack on test set to OUTPUT CP jack on 3A pulse generating test set.																	
17	Patch MF jack on test set to OUTPUT NCP jack on 3A pulse generating test set.																	
18	Prepare 4A signaling test set equipped with loop interface unit as outlined in the section titled 4A Signaling Test Set Description and Operation.																	
19	Patch PLS jack on test set to SR jack on 4A signaling test set loop interface unit.																	
20	Patch MF jack on test set to SR jack on 4A signaling test set loop interface unit.																	
21c	If TM jack access is provided — Patch T1 jack of voltmeter test circuit to TM jack of trunk test circuit.																	
22c	At trunk test circuit — Block ST relay operated.																	
23d	If TM1 and TM2 jack access is provided — Patch T1 jack of voltmeter test circuit to TM1 jack of jack, lamp, and key circuit.																	

— Omit Step

■ Proceed to METHOD

3. PREPARATION (Cont)

Note: Refer to 1.05, 1.06, 1.09, 1.11, and 1.12.

STEP	ACTION	TEST															
		O	P	Q	Q.I	R	S	T	U	V	W	X	Y	Z	AA	AB	AC
1	At MTF — Restore all keys and switches.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
2	Momentarily operate RL key.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
3	Select dial tone marker having access to originating register under test (refer to 1.09).	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
4	Select OR class of test.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
5	Select route advance 0.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
6	Select originating register group.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
7	Select originating register to be tested.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
8	Operate TRR key.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
9	Operate FS, TS keys.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
10	Patch RC jack on test set to RC jack on MTF or to RC jack on originating register frame.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
11a	If performing dial pulsing tests — Patch ORT jack on test set to ORT jack on MTF or to ORT jack on originating register frame.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
12a	Patch handset to PLS jack of test set.	X	X	X	X	X	X	X	X	X		X	X	X	X	X	X
13b	If performing TOUCH-TONE dialing tests — Patch IRT connector on test set to IRT jack on MTF or to IRT jack on originating register frame.								X								
14b	Patch handset to ORT jack of test set.	X	X	X	X				X								

3. PREPARATION

Note: Refer to 1.05, 1.06, 1.09, 1.11, and 1.12.

STEP	ACTION	TEST															
		O	P	Q	Q.1	R	S	T	U	V	W	X	Y	Z	AA	AB	AC
15	Prepare 3A pulse generating test set as outlined in the section titled 3A Pulse Generating Test Set Description and Operation.																
16	Patch PLS jack on test set to OUTPUT CP jack on 3A pulse generating test set.																
17	Patch MF jack on test set to OUTPUT NCP jack on 3A pulse generating test set.																
18	Prepare 4A signaling test set equipped with loop interface unit as outlined in the section titled 4A Signaling Test Set Description and Operation.																
19	Patch PLS jack on test set to SR jack on 4A signaling test set loop interface unit.																
20	Patch MF jack on test set to SR jack on 4A signaling test set loop interface unit.																
21c	If TM jack access is provided — Patch T1 jack of voltmeter test circuit to TM jack of trunk test circuit.																
22c	At trunk test circuit — Block ST relay operated.																
23d	If TM1 and TM2 jack access is provided — Patch T1 jack of voltmeter test circuit to TM1 jack of jack, lamp, and key circuit.																

— Omit Step

▣ Proceed to METHOD

3. PREPARATION (Cont)

Note: Refer to 1.05, 1.06, 1.09, 1.11, and 1.12.

STEP	ACTION	TEST															
		AD	AD.1	AE	AF	AG	AH	AI	AJ	AK	AL	AM	AN	AN.1	AO	AO.1	AP
1	At MTF — Restore all keys and switches.	X	X	X	X	X	X		X	X	X	X	X	X	X	X	X
2	Momentarily operate RL key.	X	X	X	X	X	X		X	X	X	X	X	X	X	X	X
3	Select dial tone marker having access to originating register under test (refer to 1.09).	X	X	X	X	X	X		X	X	X	X	X	X	X	X	X
4	Select OR class of test.	X	X	X	X	X	X		X	X	X	X	X	X	X	X	X
5	Select route advance 0.	X	X	X	X	X	X		X	X	X	X	X	X	X	X	X
6	Select originating register group.	X	X	X	X	X	X		X	X	X	X	X	X	X	X	X
7	Select originating register to be tested.	X	X	X	X	X	X		X	X	X	X	X	X	X	X	X
8	Operate TRR key.	X	X	X	X	X	X		X	X	X	X	X	X	X	X	X
9	Operate FS, TS keys.	X	X	X	X	X	X		X	X	X	X	X	X	X	X	X
10	Patch RC jack on test set to RC jack on MTF or to RC jack on originating register frame.	X	X	X	X	X	X		X	X	X	X	X	X	X	X	X
11a	If performing dial pulsing tests — Patch ORT jack on test set to ORT jack on MTF or to ORT jack on originating register frame.	X	X	X	X	X	X		—	—	—	—	—	—	—	—	—
12a	Patch handset to PLS jack of test set.	—	—	X	X	X	X		—	—	—	—	—	—	—	—	—
13b	If performing TOUCH-TONE dialing tests — Patch IRT connector on test set to IRT jack on MTF or to IRT jack on originating register frame.						X		X	X	X	X	X	X	X	X	X
14b	Patch handset to ORT jack of test set.	—	—				X		X	X	X	X	X	X	X	X	X

3. PREPARATION

Note: Refer to 1.05, 1.06, 1.09, 1.11, and 1.12.

STEP	ACTION	TEST															
		AD	AD.1	AE	AF	AG	AH	AI	AJ	AK	AL	AM	AN	AN.1	AO	AO.1	AP
15	Prepare 3A pulse generating test set as outlined in the section titled 3A Pulse Generating Test Set Description and Operation.	X	—										X	—	X	—	X
16	Patch PLS jack on test set to OUTPUT CP jack on 3A pulse generating test set.	X	—										—	—	—	—	—
17	Patch MF jack on test set to OUTPUT NCP jack on 3A pulse generating test set.												X		X		X
18	Prepare 4A signaling test set equipped with loop interface unit as outlined in the section titled 4A Signaling Test Set Description and Operation.		X											X		X	
19	Patch PLS jack on test set to SR jack on 4A signaling test set loop interface unit.		X											—		—	
20	Patch MF jack on test set to SR jack on 4A signaling test set loop interface unit.													X		X	
21c	If TM jack access is provided — Patch T1 jack of voltmeter test circuit to TM jack of trunk test circuit.																
22c	At trunk test circuit — Block ST relay operated.																
23d	If TM1 and TM2 jack access is provided — Patch T1 jack of voltmeter test circuit to TM1 jack of jack, lamp, and key circuit.																

— Omit Step

☐ Proceed to METHOD

3. PREPARATION (Cont)

Note: Refer to 1.05, 1.06, 1.09, 1.11, and 1.12.

STEP	ACTION	TEST															
		AP.1	AQ	AQ.1	AR	AS	AT	AU	AV	AW	AX	AY	AZ	BA	BB	BC	
1	At MTF — Restore all keys and switches.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	
2	Momentarily operate RL key.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	
3	Select dial tone marker having access to originating register under test (refer to 1.09).	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	
4	Select OR class of test.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	
5	Select route advance 0.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	
6	Select originating register group.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	
7	Select originating register to be tested.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	
8	Operate TRR key.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	
9	Operate FS, TS keys.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	
10	Patch RC jack on test set to RC jack on MTF or to RC jack on originating register frame.	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	
11a	If performing dial pulsing tests — Patch ORT jack on test set to ORT jack on MTF or to ORT jack on originating register frame.	—	—	—	X	X	X	X	X	X	X	X	—	X	X	X	
12a	Patch handset to PLS jack of test set.	—	—	—	X	X	X	X	X	X	X	X	—	X	X	X	
13b	If performing TOUCH-TONE dialing tests — Patch IRT connector on test set to IRT jack on MTF or to IRT jack on originating register frame.	X	X	X	X			X		X	X	X	X	X	X	X	
14b	Patch handset to ORT jack of test set.	X	X	X	X			X		X	X	X	X	X	X	X	

3. PREPARATION

Note: Refer to 1.05, 1.06, 1.09, 1.11, and 1.12.

STEP	ACTION	TEST															
		AP.1	AQ	AQ.1	AR	AS	AT	AU	AV	AW	AX	AY	AZ	BA	BB	BC	
15	Prepare 3A pulse generating test set as outlined in the section titled 3A Pulse Generating Test Set Description and Operation.	—	X	—											X		
16	Patch PLS jack on test set to OUTPUT CP jack on 3A pulse generating test set.	—	—	—											X		
17	Patch MF jack on test set to OUTPUT NCP jack on 3A pulse generating test set.	—	X	—											X		
18	Prepare 4A signaling test set equipped with loop interface unit as outlined in the section titled 4A Signaling Test Set Description and Operation.	X		X											X		
19	Patch PLS jack on test set to SR jack on 4A signaling test set loop interface unit.	—		—											X		
20	Patch MF jack on test set to SR jack on 4A signaling test set loop interface unit.	X		X											X		
21c	If TM jack access is provided — Patch T1 jack of voltmeter test circuit to TM jack of trunk test circuit.											X			X		
22c	At trunk test circuit — Block ST relay operated.											X			X		
23d	If TM1 and TM2 jack access is provided — Patch T1 jack of voltmeter test circuit to TM1 jack of jack, lamp, and key circuit.											X			X		

— Omit Step

█ Proceed to METHOD

4. METHOD

STEP	ACTION	VERIFICATION
A. Regular Call		
15	Operate keys and set switches in accordance with Test Chart Test 1.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, number dialed, class of service, RP if ring party, TP if tip party designations perforated. For Tests 1 through 16— LT designation perforated. For Tests 17 through 22, 25 through 30— FAC, LT designations perforated. For Tests 23, 24, 31, 32— FAC, LT3 designations perforated. If office is arranged for both 2-wire and 4-wire originating registers— 2W designation perforated. For Tests 7, 8, 15, 16, 19, 25— On coin service improvement (dial-tone-first)— CPT lamp momentarily lighted. OLF lamp <i>not</i> lighted.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 2 through 32.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
B. Marker Coin Return		
13	Operate keys and set switches in accordance with Test Chart Test 33.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. At MTF— CR, CND lamps lighted. Two trouble records taken. PK, SCK, CNR, CNS, DIS1 designations

STEP	ACTION	VERIFICATION
		perforated on first card. PK, CR, CNS designations perforated on second card.
16	At test set— Momentarily operate RL key.	All lamps extinguished.
17	Restore all keys and switches and remove all patching cords not required in next test.	
C. Preliminary Pulse—Register not Arranged for Centrex		
15	Operate keys and set switches in accordance with Test Chart Test 34.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17c	If register prefix counter is not provided— At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone heard after each digit 1. Register AS relay remains operated.
18d	If register prefix counter is provided— At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Register AS relay remains operated. If register is equipped to remove dial tone after a single prefix digit 1— Dial tone silenced after first digit 1. If register is equipped to remove dial tone after prefix digits 11— Dial tone removed after second digit 1. If register is not equipped to remove dial tone after prefix digit 1 or prefix digits 11— Dial tone heard after each digit 1.
19	Momentarily operate RL key.	All lamps extinguished.
20	Repeat Steps 15 through 19, as required for Test 35.	
21	Restore all keys and switches and remove all patching cords not required in next test.	
D. Manual Call—Coin or Noncoin		
13	Operate keys and set switches in accordance with Test Chart Test 36.	
14	At test set— Momentarily operate STT key.	Dial tone <i>not</i> heard. At MTF— AS lamp lighted.

STEP	ACTION	VERIFICATION
		Trouble record taken. A4, 7 designations perforated. On coin calls— At MTF— CR lamp momentarily lighted. CND lamp lighted. CNS designation perforated.
15	At test set— Momentarily operate RL key.	All lamps extinguished.
16	Repeat Steps 13 through 15, as required for Test 37.	
17	Restore all keys and switches and remove all patching cords not required in next test.	
E. 11 Prefix Foreign Area Directing Code		
15	Operate keys and set switches in accordance with Test Chart Test 38.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, 11, and digits dialed designations perforated.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 39 through 41.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
F. 11X Service Codes		
15	Operate keys and set switches in accordance with Test Chart Test 42.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, 11, A_digit dialed designations perforated.

STEP	ACTION	VERIFICATION
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 43 through 45.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
G. X11 Service Codes and DDD Information Codes		
15	Operate keys and set switches in accordance with Test Chart Test 46.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, and digits dialed designations perforated. For Tests 46, 49— LT, OR designations perforated. For Tests 47, 50— LT1, OR designations perforated. For Tests 48, 51— X11, FAC designations perforated.
Note: For Tests 48, 51, if NPA code selected is an interchangeable code, a trouble record will be taken in 3 to 5 seconds.		
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 47 through 51.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
H. Prefix Digit 1		
15	Operate keys and set switches in accordance with Test Chart Test 52.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, LT1, and digits dialed designations

SECTION 218-135-503

STEP	ACTION	VERIFICATION
		perforated. For Tests 52, 53, 55, 56— OR designation perforated. For Tests 54, 57— FAC designation perforated.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 53 through 57.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
I. Abandoned Call—Coin, Noncoin, DDD, or Centrex		
13	Operate keys and set switches in accordance with Test Chart Test 58.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	
16	Operate DIS key.	Register released without selecting marker. No trouble record taken. APD or FAPD (DDD call) traffic register scored. On coin calls other than coin service improvement (dial-tone-first) calls— At MTF— CR lamp momentarily lighted. CND lamp lighted. On coin service improvement (dial-tone-first) calls— CR, CPT lamps momentarily lighted. CND lamp lighted. OLF lamp not lighted.
17	At test set— Momentarily operate RL key.	All lamps extinguished.
18	Restore DIS key.	
19	Repeat Steps 13 through 18, as required for Tests 59 through 61.	
20	Restore all keys and switches and remove all patching cords not required in next test.	

STEP	ACTION	VERIFICATION
J. Abandoned Call During Coin Test		
13	Insert make-busy plug into ORMB_ jack associated with register under test.	
14	At register frame— Block nonoperated GT1 relay.	
15b	If registers are arranged for coin-first operation— Operate keys and set switches in accordance with Test Chart Test 62.	
16b	At test set— Momentarily operate STT key.	Dial tone <i>not</i> heard. At MTF— AS lamp lighted.
17b	At test set— Operate DIS key.	Register released without selecting marker. No trouble record taken.
18b	At test set— Momentarily operate RL key.	All lamps extinguished.
19b	Restore DIS key.	
20c	If registers are arranged for dial-tone-first— Operate keys and set switches in accordance with Test Chart Test 63.	
21c	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced.
22c	Operate DIS key.	Register released without selecting marker. No trouble record taken.
23c	Momentarily operate RL key.	All lamps extinguished.
24c	Restore DIS key.	
25	At register frame— Remove blocking tool from GT1 relay.	
26	At MTF— Remove make-busy plug from ORMB_ jack.	
27	Restore all keys and switches and remove all patching cords not required in next test.	
K. Two-Party Test		
13	Operate keys and set switches in accordance with Test Chart Test 64.	

SECTION 218-135-503

STEP	ACTION	VERIFICATION
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, TP if tip party; RP if ring party designations perforated.
16	Momentarily operate RL key.	All lamps extinguished.
17	Repeat Steps 13 through 16, as required for Tests 65 through 67.	
18	Restore all keys and switches and remove all patching cords not required in next test.	
L. Start Pulse Signal		
13	Operate keys and set switches in accordance with Test Chart Test 68.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At register frame— RV relay operated.
15	At test set— Momentarily operate RL key.	Dial tone silenced. All lamps extinguished.
16	Restore all keys and switches and remove all patching cords not required in next test.	
M. Zero Operator		
15	Operate keys and set switches in accordance with Test Chart Test 69.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17c	If register is not arranged for person-to-person collect special calls— At test set— Dial digit 0 (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. A4, 7; B7 designations perforated. On coin calls other than coin service improvement (dial-tone-first) calls— When register is arranged for coin return on calls to operator trunks— At MTF— CR lamp momentarily lighted. CND lamp lighted. On coin service improvement (dial-tone-first)

STEP	ACTION	VERIFICATION
		calls— SCK designation perforated.
18d	If register is arranged for person-to-person collect special calls— At test set— Dial digit 0 (refer to paragraph 3.01); start timing.	If register is equipped with transistor digit timer— In 3 to 4 seconds— Trouble record taken. If register is equipped with cold-cathode tube digit timer— In 3 to 5 seconds— Trouble record taken. A4, 7; B7 designations perforated. On coin calls other than coin service improvement (dial-tone-first) calls— When register is arranged for coin return on calls to operator trunks— At MTF— CR lamp momentarily lighted. CND lamp lighted. On coin service improvement (dial-tone-first) calls— SCK designation perforated.
19	At test set— Momentarily operate RL key.	All lamps extinguished.
20	Repeat Steps 15 through 19, as required for Tests 70 through 74.	
21	Restore all keys and switches and remove all patching cords not required in next test.	
N. Prefix Digits 0+		
15	Operate keys and set switches in accordance with Test Chart Test 75.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. LT2, digits dialed designations perforated.
	Note: Begin dialing digits within 3 seconds after dialing 0 prefix digit.	
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 19, as required for Tests 76 through 80.	

SECTION 218-135-503

STEP	ACTION	VERIFICATION
20	Restore all keys and switches and remove all patching cords not required in next test.	
N.1 Prefix Digits 01+		
15	Operate keys and set switches in accordance with Test Chart Test 81.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01). <i>Note:</i> Begin dialing digits within 3 seconds after dialing 01 prefix digits.	Dial tone silenced. Trouble record taken. FAC, FVD, digits dialed designations perforated.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18 as required for Tests 82 through 100.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
N.2 Prefix Digits 011+		
15	Operate keys and set switches in accordance with Test Chart Test 101.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01). <i>Note:</i> Begin dialing digits within 3 seconds after dialing 011 prefix digits.	Dial tone silenced. For Tests 101 through 130. Trouble record taken. FAC, 11, digits dialed designations perforated. For Tests 131 through 135. Overflow tone heard.
18	Momentarily operate RL key.	All lamps extinguished. Overflow tone silenced.
19	Repeat Steps 15 through 18, as required for Tests 102 through 135.	
20	Restore all keys and switches and remove all patching cords not required in next test.	

STEP	ACTION	VERIFICATION
O. A_ Digit Translation		
15	Operate keys and set switches in accordance with Test Chart Test 136.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, digits dialed designations perforated. LT1 designation perforated.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 137 through 157.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
P. Combination A_ and B_ Digit Translation		
15	Operate keys and set switches in accordance with Test Chart Test 158.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, digits dialed designations perforated. LT1 designation perforated.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 159 through 179.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
Q. Pretranslation (SD-25568-01 Provided)		
15	Operate keys and set switches in accordance with Test Chart Test 180.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.

SECTION 218-135-503

STEP	ACTION	VERIFICATION
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, digits dialed designations perforated. If digit 0, 1, or 8 was prefixed to number dialed— LT2, LT1, or LT3 designation perforated, respectively.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 181 through 237.	
20	Restore all keys and switches and remove all patching cords not required in next test.	

Q.1 Pretranslation for IDDD (SD-27849-01 Provided)

15	Operate keys and set switches in accordance with Test Chart Test 238.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, digits dialed designations perforated. If 01 or 011 was prefixed to number dialed— FVD or 11 designation perforated, respectively.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 239 through 254.	
20	Restore all keys and switches and remove all patching cords not required in next test.	

R. Stuck Coin

13	Operate keys and set switches in accordance with Test Chart Test 255.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. At MTF— CND lamp lighted. If register is not arranged for person-to-person

STEP	ACTION	VERIFICATION
		collect special calls— Trouble record taken. SCN, CNS designations perforated. If register is arranged for person-to-person collect special calls— In 3 to 4 seconds— Trouble record taken. SCN, CNS designations perforated.
16	At test set— Momentarily operate RL key.	All lamps extinguished.
17	Restore all keys and switches and remove all patching cords not required in next test.	
S. Straightforward Call to Manual Office		
13	Operate keys and set switches in accordance with Test Chart Test 256.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, and digits dialed designations perforated.
16	Momentarily operate RL key.	All lamps extinguished.
17	Restore all keys and switches and remove all patching cords not required in next test.	
T. Permanent Signal Timing—Coin or Noncoin		
13	Operate keys and set switches in accordance with Test Chart Test 257.	
14	Insert make-busy plug into ORMB_ jack associated with register under test.	
15	At test set— Momentarily operate STT key; <i>start timing.</i>	Dial tone heard. At MTF— AS lamp lighted. In 20 to 32 seconds— AS lamp extinguished. Trouble record taken. PS designation perforated. On coin calls other than coin service improvement (dial-tone-first) calls— CR lamp momentarily lighted.

SECTION 218-135-503

STEP	ACTION	VERIFICATION
		CND lamp lighted. On coin service improvement (dial-tone-first) calls— CR, CPT lamps momentarily lighted. CND lamp lighted. OLF lamp <i>not</i> lighted.
16	At test set— Momentarily operate RL key.	All lamps extinguished. Dial tone silenced.
17	Momentarily restore CN key if operated.	
18	At group-busy circuit— Block operated RB2 relay in group-busy circuit associated with register to be tested.	
19	At test set— Momentarily operate STT key; <i>start timing</i> .	Dial tone heard. At MTF— AS lamp lighted. In 10 to 16 seconds— AS lamp extinguished. Trouble record taken. On coin calls other than coin service improvement (dial-tone-first) calls— CR lamp momentarily lighted. CND lamp lighted. On coin service improvement (dial-tone-first) calls— CR, CPT lamps momentarily lighted. CND lamp lighted. OLF lamp <i>not</i> lighted.
20	At test set— Momentarily operate RL key.	All lamps extinguished. Dial tone silenced.
21	At group-busy circuit— Remove blocking tool from RB2 relay.	
22	At test set— Restore CN key if operated.	
23	Repeat Steps 13 through 22, as required for Test 258.	
24	At MTF— Remove make-busy plug from ORMB_ jack.	
25	Restore all keys and switches and remove all patching cords not required in next test.	

STEP	ACTION	VERIFICATION
U. Partial Dial Timing—Coin, Noncoin, or Overload Condition		
15	Operate keys and set switches in accordance with Test Chart Test 259.	
16	Insert make-busy plug in ORMB_jack associated with register under test.	
For Tests 259, 260, 262 Through 267		
17	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
18	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01); <i>start timing</i> .	Dial tone silenced. For Tests 259, 260, 262 through 267— In 20 to 32 seconds— Trouble record taken. PD, and digits dialed designations perforated. On coin service improvement (dial-tone-first) calls— SCK designation perforated. For Tests 266 and 267— If register is equipped with transistor digit timer— In 3 to 4 seconds— Trouble record taken. If register is equipped with cold-cathode tube digit timer— In 3 to 5 seconds— Trouble record taken. PD, and digits dialed designations perforated.
19	Momentarily operate RL key.	All lamps extinguished.
20	Momentarily restore CN key if operated.	
21	At group-busy circuit— Block operated RB2 relay in group-busy circuit associated with register to be tested.	
22	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
23	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01); <i>start timing</i> .	Dial tone silenced. In 5 to 8 seconds— Trouble record taken. PD and digits dialed designations perforated.

SECTION 218-135-503

STEP	ACTION	VERIFICATION
24	At group-busy circuit— Remove blocking tool from RB2 relay.	
25	At test set— Momentarily operate RL key.	All lamps extinguished.
26	Restore CN key if operated.	

For Test 261

27	At register frame— Block operated OVL relay.	
28	Block nonoperated DT relay.	
29	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
30	At test set— Dial digits as shown on Test Chart (refer to paragraph 3.01); <i>start timing</i> .	Dial tone silenced. In 4.6 to 7.2 seconds Trouble record taken. PD designation perforated.
31	Momentarily operate RL key.	All lamps extinguished.
32	At register frame— Remove blocking tools from OVL, DT relays.	
33	Repeat Steps 15 through 32, as required for Tests 260 through 267.	
34	At MTF— Remove make-busy plug from ORMB_ jack.	
35	Restore all keys and switches and remove all patching cords not required in next test.	

V. Register Timeout After Marker Sets Busy Tone

13	Operate keys and set switches in accordance with Test Chart Test 268.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01); <i>start timing</i> .	Dial tone silenced. Busy tone heard.

STEP	ACTION	VERIFICATION
16	At MTF— Restore RLT key; operate HLD key.	In 20 to 32 seconds— TO_ lamp lighted. AS lamp extinguished. Busy tone silenced. After 10 to 15 seconds— R-S-TOA lamp lighted. Major alarm sounds.
17	At test set— Momentarily operate RL key.	All lamps extinguished. Major alarm silenced.
18	Restore all keys and switches and remove all patching cords not required in next test.	
W. Tip Party—Manual Test		
1	At MTF— Insert make-busy plug into ORMB_ jack for originating register to be tested.	
2	At register frame— Block operated 2P relay.	
3	Block nonoperated TP1 relay.	
4	Manually operate ON1 relay.	ON1 relay locked operated. ON, RL relays operated.
5	Remove blocking tool from TP1 relay.	ON1, ON, RL relays released.
6	Momentarily operate ON1 relay manually.	TP1 relay operated while ON1 relay operated.
7	Remove blocking tool from 2P relay.	
8	At MTF— Remove make-busy plug from ORMB_ jack.	
X. Timing During Pretranslation		
13	Operate keys and set switches in accordance with Test Chart Test 269.	
14	Insert make-busy plug into ORMB_ jack of originating register to be tested.	
15	At group-busy circuit— Block operated RB2 relay in group-busy circuit associated with register to be tested.	
16b	If nonwire-spring-relay type circuits are used— At register frame— Insulate 1-3B, 3-4B of PRL relay.	

SECTION 218-135-503

STEP	ACTION	VERIFICATION
17c	If wire-spring-relay type circuits are used— At register frame— Insulate 7B, 9B of PRL relay.	
18	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
19	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01); <i>start timing</i> .	Dial tone silenced. At register frame— PST relay operated. OVL relay released. In 20 to 32 seconds— TM relay operated.
20	At test set— Momentarily operate RL key.	All lamps extinguished.
21	At group-busy circuit— Remove blocking tool from RB2 relay.	
22	Remove insulators from PRL relay.	
23	Repeat Steps 13 through 22, as required for Test 270.	
24	At MTF— Remove plug from ORMB_ jack.	
25	Restore all keys and switches and remove all patching cords not required in next test.	

Y. Timing During Coin Test—Dial-Tone-First

13	Operate keys and set switches in accordance with Test Chart Test 271.	
14	Insert make-busy plug into ORMB_ jack associated with register under test.	
15	At register frame— Block nonoperated OVL relay.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01); <i>start timing</i> .	Dial tone silenced. In 10 to 16 seconds— No-such-number tone heard. In 20 to 32 seconds— No-such-number tone silenced.

STEP	ACTION	VERIFICATION
18	Momentarily operate RL key.	All lamps extinguished.
19	At register frame— Remove blocking tool from OVL relay.	
20	At MTF— Remove make-busy plug from ORMB_ jack.	
21	Restore all keys and switches and remove all patching cords not required in next test.	
Z. Common Alarm Timing		
13	Operate keys and set switches in accordance with Test Chart Test 272.	
14	At test set— Momentarily operate STT key; <i>start timing.</i>	Dial tone heard. At MTF— AS lamp lighted. In 20 to 32 seconds— Dial tone silenced. After 20 to 32 seconds— TO_ lamp lighted. After 10 to 15 seconds— R-S-TOA lamp lighted. Major alarm sounds.
15	Insert make-busy plug into ORMB_ jack associated with originating register under test.	R-S-TOA lamp extinguished. Major alarm silenced.
16	At test set— Momentarily operate RL key.	All lamps extinguished.
17	At MTF— Remove make-busy plug from ORMB_ jack.	
18	Restore all keys and switches and remove all patching cords not required in next test.	
AA. Recycle of Timing		
13	Operate keys and set switches in accordance with Test Chart Test 273.	
14	Insert make-busy plug into ORMB_ jack associated with originating register under test.	
15	At test set— Observe register TMA, TMB, TMC relays; momentarily operate STT key (refer to paragraph 3.01).	At register frame— Register Arranged for Coin Test Before Dial Tone Register TMA, TMB relays operate, release, reoperate when coin test is satisfied to recycle

SECTION 218-135-503

STEP	ACTION	VERIFICATION
		<p>timing for permanent signal timing.</p> <p>Register Arranged for Coin Test After Dialing, Arranged for Coin Service Without Coin Test, or not Arranged for Coin Service</p> <p>Register TMA, TMB relays operated to start permanent signal timing.</p> <p>If TOUCH-TONE pulsing is provided— TMC relay operated.</p>
16	Dial digit A_ shown on Test Chart (refer to paragraph 3.01).	<p>At register frame— Register TMA relay released, then reoperated to recycle timing circuit for partial dial timing.</p> <p>If TOUCH-TONE pulsing is provided— TMC relay released, then reoperated.</p>
17	Dial remaining digits shown on Test Chart (refer to 3.01).	<p>At register frame— Register TMA, TMB relays released, operated for each digit.</p> <p>If TOUCH-TONE pulsing is provided— TMC relay released then reoperated for each digit.</p> <p>At completion of dialing— TMA relay operated. TMB relay nonoperated.</p> <p>If TOUCH-TONE pulsing is provided— TMC relay operated.</p>
18	At test set— Momentarily operate RL key.	All lamps extinguished.
19b	If register is arranged to make coin test after completion of dialing— At register frame— Block nonoperated GT1 relay.	
20b	At test set— Momentarily operate STT key.	
21b	Dial digits shown on Test Chart to advance register to coin test (refer to paragraph 3.01); start timing after last digit.	At register frame— CNT3 relay operated.
22b	At test set— Momentarily operate RL key.	All lamps extinguished.
23b	At register frame— Remove blocking tool from GT1 relay.	
24c	If register is arranged for coin service without coin test or if register is arranged for coin test before dial tone—	

STEP	ACTION	VERIFICATION
	At register frame— Block nonoperated CR1 relay.	
25c	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
26c	At register frame— Momentarily operate TM relay.	TMA relay released, reoperated. TMB relay nonoperated.
27c	Remove blocking tool from CR1 relay.	Register advanced through coin return cycle.
28c	At test set— Momentarily operate RL key.	All lamps extinguished.
29	Repeat Steps 13 through 23b or 28c, as required for Test 274.	
30	At MTF— Remove make-busy plug from ORMB_ jack.	
31	Restore all keys and switches and remove all patching cords not required in next test.	
AB. Dial Tone Removal		
13	Operate keys and set switches in accordance with Test Chart Test 275.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	For Tests 275, 276, 277, 279— Dial tone removed. For Test 278— If register is arranged for centrex and dial tone is removed after directing digit 9— Dial tone silenced after digit 9 is dialed. If register is arranged for centrex and dial tone is returned after directing digit 9— Dial tone still heard after digit 9 is dialed.
16	Momentarily operate RL key.	All lamps extinguished.
17	Repeat Steps 13 through 16, as required for Tests 276 through 279.	
18	Restore all keys and switches and remove all patching cords not required in next test.	

SECTION 218-135-503

STEP	ACTION	VERIFICATION
AC. Line Location, Class of Service, Observed Call, Storing, and Verification of Trouble Recorder Leads		
13	Operate keys and set switches in accordance with Test Chart Test 280. <i>Note:</i> Do not select a line location used for a long-loop customer with range extension for unigauge cabling.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digit 0 (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, FR, CN, RG, NOB or OBS CT, CU, CGA or CGB CR, FT, FU, VG, HG, VF, CNS, and RP or TP designations perforated. If dial pulsing is provided— DT designation perforated. If TOUCH-TONE pulsing is provided— MF designation perforated.
16	Momentarily operate RL key.	All lamps extinguished.
17	Repeat Steps 13 through 16, as required for Tests 281 through 292.	
18	Restore all keys and switches and remove all patching cords not required in next test.	
AD. Precision Pulsing Test (3A Pulse Generating Test Set)		
17	Operate keys and set switches in accordance with Test Chart Test 293.	
18	At pulse generating test set— Adjust settings so interdigital time is 185 milliseconds; pulses per second and percent break correspond to information on Test Chart with LOOP key in CLOSED position.	
19	Set PULSE SEL switch to CONTINUOUS and set PULSES PER TRAIN switch to agree with number of pulses for digit A on Test Chart.	

STEP	ACTION	VERIFICATION
20	At test set (register)— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
21	At pulse generating test set— Operate TRAIN CONTROL key to PULSE (refer to paragraph 3.01).	
22	Observe number of digits pulsed with counter tube.	At test set (register)— Dial tone silenced. At MTF— Trouble record taken. Digits on Test Chart match designations perforated.
		Note: Designations perforated may indicate a 3- digit vacant code or a 7-digit local area code.
23	Operate TRAIN CONTROL key to NOR.	
24	Momentarily operate RL key.	All lamps extinguished.
25	Repeat Steps 17 through 24, as required for Tests 294 through 298.	
26	Restore all keys and switches and remove all patching cords not required in next test.	
AD.1 Precision Pulsing Test (4A Signaling Test Set)		
20	Operate keys and set switches in accordance with Test Chart Test 299.	
21	At signaling test set—main module— Adjust settings so pulses per second and percent break correspond to information on Test Chart.	OPERATE-CLEAR lamp lighted.
22	At signaling test set—loop interface unit— Set FUNCTION switch to SR.	
23	At test set (register)— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
24	At signaling test set—main module— Momentarily operate keyset # key to allow a repeated discrete train of pulses with an interdigital time of 185 ms.	

SECTION 218-135-503

STEP	ACTION	VERIFICATION
25	Momentarily operate a keyset key to agree with number of pulses for digit A ₁ on Test Chart (refer to paragraph 3.01).	WAIT TO DIAL lamp lighted. At test set (register)— Dial tone silenced. At MTF— Trouble record taken. Digits on Test Chart match designations perforated. <i>Note:</i> Designations perforated may indicate a 3-digit vacant code or a 7-digit local area code.
26	At signaling test set—main module— Operate OPERATE-CLEAR key to CLEAR.	OPERATE-CLEAR lamp extinguished. WAIT TO DIAL lamp extinguished.
27	At test set (register)— Momentarily operate RL key.	All lamps extinguished.
28	Repeat Steps 20 through 27, as required for Tests 300 through 304.	
29	Restore all keys and switches and remove all patching cords not required in next test.	

AE. Intracentrex Call

13	Operate keys and set switches in accordance with Test Chart Test 305.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— paragraph 3.01).	Dial tone is silenced. Trouble record taken. PK, SCK, number dialed, class of service designations perforated. If 4-digit call— X11 designation perforated. If 5-digit call— FVD designation perforated.
16	Momentarily operate RL key.	All lamps extinguished.
17	Repeat Steps 13 through 16, as required for Test 306.	
18	Restore all keys and switches and remove all patching cords not required in next test.	

STEP	ACTION	VERIFICATION
AF. 11X Special Codes—(Nonservice Codes) Originating Register Equipped for Centrex Service Only		
13	Operate keys and set switches in accordance with Test Chart Test 307.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, 11, A_ digit dialed designations perforated.
16	Momentarily operate RL key.	All lamps extinguished.
17	Repeat Steps 13 through 16, as required for Test 308.	
18	Restore all keys and switches and remove all patching cords not required in next test.	
AG. Zero Operator Calls for Centrex Service		
13	Operate keys and set switches in accordance with Test Chart Test 309.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digit 0 (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. A4, 7; X11 or FVD class of service designations perforated.
16	Momentarily operate RL key.	All lamps extinguished.
17	Restore all keys and switches and remove all patching cords not required in next test.	
AH. 1XX Special Codes for Centrex Service		
15	Operate keys and set switches in accordance with Test Chart Test 310.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.

SECTION 218-135-503

STEP	ACTION	VERIFICATION
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01); <i>start timing</i> .	Dial tone silenced. If a translator is used to determine exact number of digits to be registered— Trouble record taken. PK, SCK, 2DT, A_ and B_ digits dialed designations perforated. If repetitive digit timing is provided or if A_ translator is used to determine minimum number of digits to be registered with timing for a possible additional digit and register is equipped with transistor digit timer— In 3 to 4 seconds— Trouble record taken. PK, SCK, 2DT, digits dialed designations perforated. If register is equipped with cold cathode tube timer— In 3 to 5 seconds— Trouble record taken. PK, SCK, 2DT, digits dialed designations perforated. For Test 320— Trouble record immediately taken. PK, SCK, 2DT, and digits dialed designations perforated. For Tests 321, 322, and 323— Overflow tone heard.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 311 through 323.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
AI. Deleted		
AJ. Low- and High-Level Signal Test		
15	Operate keys and set switches in accordance with Test Chart Test 324.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Key digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. Digits keyed designations perforated.
18	Momentarily operate RL key.	All lamps extinguished.

STEP	ACTION	VERIFICATION
19	Repeat Steps 15 through 18, as required for Test 325.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
AK. Maximum and Minimum Frequency Test		
15	Operate keys and set switches in accordance with Test Chart Test 326.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Key digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. Digits keyed designations perforated.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Test 327.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
AL. Single-Frequency Test		
15	Operate keys and set switches in accordance with Test Chart Test 328.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Momentarily operate SF-IA key.	Dial tone still heard. At MTF— AS lamp remains lighted.
18	At test set— Key digits shown on Test Chart (refer to paragraph 3.01).	Trouble record taken. Digits keyed designations perforated.
19	Momentarily operate RL key.	All lamps extinguished.
20	Repeat Steps 15 through 19, as required for Tests 329 through 335.	
21	Restore all keys and switches and remove all patching cords not required in next test.	

SECTION 218-135-503

STEP	ACTION	VERIFICATION
AM. Special Three-Frequency Test		
15	Operate keys and set switches in accordance with Test Chart Test 336.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Momentarily operate SF-IA key.	Dial tone still heard. At MTF— AS lamp remains lighted.
18	At test set— Key digits shown on Test Chart (refer to paragraph 3.01).	Trouble record taken. Digits keyed designations perforated.
19	Momentarily operate RL key.	All lamps extinguished.
20	Repeat Steps 15 through 19, as required for Tests 337 through 339.	
21	Restore all keys and switches and remove all patching cords not required in next test.	
AN. Regular Precision Pulsing Test—TOUCH-TONE Calling (3A Pulse Generating Test Set)		
18	Operate keys and set switches in accordance with Test Chart Test 340.	
19	At pulse generating test set— Adjust settings for 11 pulses per second at 56 percent break with LOOP key in OPEN position.	
20	Set PULSE SEL switch to SINGLE TRAIN.	
21	Set PULSE PER TRAIN switch to 3.	
22	Operate LOOP key to CLOSED.	
23	At test set (register)— Set L switch to OFF.	
24	Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
25	At test set (register)— Key A, B, C digits in accordance with Test Chart (refer to paragraph 3.01).	

STEP	ACTION	VERIFICATION
26	At pulse generating test set— Operate LOOP key to OPEN.	
27	At test set (register)— Depress and hold key in accordance with DEPRESS and HOLD KEY column on Test Chart.	
28	At pulse generating test set— Operate TRAIN CONTROL key to PULSE.	At test set (register)— Dial tone silenced. At MTF— Trouble record taken. A, B, C digits designations perforated. D, E, F, G digits designations perforated corresponding to key held in Step 27.
29	At test set register— Release key held in Step 27.	
30	Momentarily operate RL key.	All lamps extinguished.
31	At pulse generating test set— Operate TRAIN CONTROL key to NOR.	
32	Repeat Steps 18 through 31, as required for Tests 341 through 343.	
33	Restore all keys and switches and remove all patching cords not required in next test.	
AN. 1	Regular Precision Pulsing Test—TOUCH-TONE Calling (4A Signaling Test Set)	
21	Operate keys and set switches in accordance with Test Chart Test 344.	
22	At signaling test set—main module— Adjust settings for 11 pulses per second at 56 percent break.	
23	Operate GEN SUPV key to ON HK.	
24	At signaling test set-loop interface unit— Set FUNCTION switch to SR.	
25	At test set (register)— Set L switch to OFF.	Dial tone heard. At MTF— AS lamp lighted.
27	At test set (register)— Key A, B, C digits in accordance with Test Chart (refer to paragraph 3.01).	

SECTION 218-135-503

STEP	ACTION	VERIFICATION
28	At signaling test set—main module— Operate GEN SUPV key to OFF HK.	
29	At test set (register)— Depress and hold key in accordance with DEPRESS AND HOLD KEY column on Test Chart.	
30	At signaling test set—main module— Momentarily operate keyset * key.	
31	Momentarily operate keyset 1 key.	WAIT TO DIAL lamp lighted. At test set (register)— Dial tone silenced. At MTF— Trouble record taken. A_, B_, C_ digits designations perforated. D_, E_, F_, G_ digits designations perforated corresponding to key held in Step 29.
32	At signaling test set—main module— Operate OPERATE-CLEAR key to CLEAR.	OPERATE-CLEAR lamp extinguished. WAIT TO DIAL lamp extinguished.
33	At test set (register)— Momentarily operate RL key.	All lamps extinguished.
34	Repeat Steps 21 through 33, as required for Tests 345 through 347.	
35	Restore all keys and switches and remove all patching cords not required in next test.	
AO. Low Level Precision Pulsing Test (3A Pulse Generating Test Set)		
18	Operate keys and set switches in accordance with Test Chart Test 348.	
19	At pulse generating test set— Adjust settings for 11 pulse per second at 56 percent break with LOOP key in OPEN position.	
20	Set PULSE SEL switch to SINGLE TRAIN.	
21	Set PULSES PER TRAIN switch to 3.	
22	Operate LOOP key to CLOSED.	
23	At test set (register)— Set L switch to OFF.	

STEP	ACTION	VERIFICATION
24	Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
25	At test set (register)— Key A_, B_, C_ digits in accordance with Test Chart (refer to paragraph 3.01).	
26	At pulse generating test set— Operate LOOP key to OPEN.	
27	At test set (register)— Depress and hold key in accordance with DEPRESS AND HOLD KEY column on Test Chart.	
28	At pulse generating test set— Operate TRAIN CONTROL key to PULSE.	At test set (register)— Dial tone silenced. At MTF— Trouble record taken. A_, B_, C_ digits designations perforated. D_, E_, F_, G_ digits designations perforated corresponding to key held in Step 27.
29	At test set (register)— Release key held in Step 27.	
30	Momentarily operate RL key.	All lamps extinguished.
31	At pulse generating test set— Operate TRAIN CONTROL key to NOR.	
32	Repeat Steps 18 through 31, as required for Tests 349 through 351.	
33	Restore all keys and switches and remove all patching cords not required in next test.	
AO. 1	Low-Level Precision Pulsing Test (4A Signaling Test Set)	
21	Operate keys and set switches in accordance with Test Chart Test 352.	
22	At signaling test set—main module— Adjust settings for 11 pulses per second at 56 percent break.	
23	Operate GEN SUPV key to ON HK.	
24	At signaling test set—loop interface unit— Set FUNCTION switch to SR.	

SECTION 218-135-503

STEP	ACTION	VERIFICATION
25	At test set (register)— Set L switch to OFF.	
26	Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
27	At test set (register)— Key A_, B_, C_ digits in accordance with Test Chart (refer to paragraph 3.01).	
28	At signaling test set—main module— Operate GEN SUPV key to OFF HK.	
29	At test set (register)— Depress and hold key in accordance with DEPRESS AND HOLD KEY column on Test Chart.	
30	At signaling test set—main module— Momentarily operate keyset * key.	
31	Momentarily operate keyset 1 key.	WAIT TO DIAL lamp lighted. At test set (register)— Dial tone silenced. At MTF— Trouble record taken. A_, B_, C_ digits designations perforated. D_, E_, F_, G_ digits designations perforated corresponding to key held in Step 29.
32	At signaling test set—main module— Operate OPERATE-CLEAR key to CLEAR.	OPERATE-CLEAR lamp extinguished. WAIT TO DIAL lamp extinguished.
33	At test set (register)— Momentarily operate RL key.	
34	Repeat Steps 21 through 33, as required for Tests 353 through 355.	
35	Restore all keys and switches and remove all patching cords not required in next test.	
AP. Maximum and Minimum Frequency Precision Pulsing Test (3A Pulse Generating Test Set)		
18	Operate keys and set switches in accordance with Test Chart Test 356.	
19	At pulse generating test set— Adjust settings for 11 pulses per second at	

STEP	ACTION	VERIFICATION
	56 percent break with LOOP key in OPEN position.	
20	Set PULSE SEL switch to SINGLE TRAIN.	
21	Set PULSES PER TRAIN switch to 4.	
22	Operate LOOP key to CLOSED.	
23	At test set (register)— Set L switch to OFF.	
24	Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
25	At test set (register)— Key A_ B_ C_ digits in accordance with Test Chart (refer to paragraph 3.01).	
26	At pulse generating test set— Operate LOOP key to OPEN.	
27	At test set (register)— Depress and hold key in accordance with DEPRESS AND HOLD KEY column on Test Chart.	
28	At pulse generating test set— Operate TRAIN CONTROL key to PULSE.	At test set (register)— Dial tone silenced. At MTF— Trouble record taken. A_ B_ C_ digits designations perforated. D_ E_ F_ G_ digit designations perforated corresponding to key held in Step 27.
29	At test set (register)— Release key held in Step 27.	
30	Momentarily operate RL key.	All lamps extinguished.
31	At pulse generating test set— Operate TRAIN CONTROL key to NOR.	
32	Repeat Steps 18 through 31, as required for Tests 357 through 363.	
33	Restore all keys and switches and remove all patching cords not required in next test.	

SECTION 218-135-503

STEP	ACTION	VERIFICATION
AP.1 Maximum and Minimum Frequency Precision Pulsing Test (4A Signaling Test Set)		
21	Operate keys and set switches in accordance with Test Chart Test 364.	
22	At signaling test set—main module— Adjust settings for 11 pulses per second at 56 percent break.	
23	Operate GEN SUPV key to ON HK.	
24	At signaling test set—loop interface unit— Set FUNCTION switch to SR.	
25	At test set (register)— Set L switch to OFF.	
26	Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
27	At test set (register)— Key A_, B_, C_ digits in accordance with Test Chart (refer to paragraph 3.01).	
28	At signaling test set—main module— Operate GEN SUPV key to OFF HK.	
29	At test set (register)— Depress and hold key in accordance with DEPRESS AND HOLD KEY column on Test Chart.	
30	At signaling test set—main module— Momentarily operate keyset * key.	
31	Momentarily operate keyset 1 key.	WAIT TO DIAL lamp lighted. At test set (register)— Dial tone silenced. At MTF— Trouble record taken. A_, B_, C_ digits designations perforated. D_, E_, F_, G_ digit designations perforated corresponding to key held in Step 29.
32	At signaling test set—main module— Operate OPERATE-CLEAR key to CLEAR.	OPERATE-CLEAR lamp extinguished. WAIT TO DIAL lamp extinguished.
33	At test set (register)— Momentarily operate RL key.	All lamps extinguished.

STEP	ACTION	VERIFICATION
34	Repeat Steps 21 through 33, as required for Tests 365 through 371.	
35	Restore all keys and switches and remove all patching cords not required in next test.	
AQ. Long Pulse Precision Pulsing Test (3A Pulse Generating Test Set)		
18	Operate keys and set switches in accordance with Test Chart Test 372.	
19	At pulse generating test set— Adjust settings for 11 pulses per second at 44 percent break with LOOP key in OPEN position.	
20	Set PULSE SEL switch to SINGLE TRAIN.	
21	Set PULSES PER TRAIN switch to 4.	
22	Operate LOOP key to CLOSED.	
23	At test set (register)— Set L switch to OFF.	
24	Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
25	At test set (register)— Key A_, B_, C_ digits in accordance with Test Chart (refer to paragraph 3.01).	
26	At pulse generating test set— Operate LOOP key to OPEN.	
27	At test set (register)— Depress and hold key in accordance with DEPRESS AND HOLD KEY column on Test Chart.	
28	At pulse generating test set— Operate TRAIN CONTROL key to PULSE.	At test set (register)— Dial tone silenced. At MTF— Trouble record taken. A_, B_, C_ digits designations perforated. D_, E_, F_, G_ digits designations perforated corresponding to key held in Step 27.
29	At test set (register)— Release key held in Step 27.	

SECTION 218-135-503

STEP	ACTION	VERIFICATION
30	Momentarily operate RL key.	All lamps extinguished.
31	At pulse generating test set— Operate TRAIN CONTROL key to NOR.	
32	Repeat Steps 18 through 31, as required for Tests 373 through 375.	
33	Restore all keys and switches and remove all patching cords not required in next test.	
AQ.1 Long Pulse Precision Pulsing Test (4A Signaling Test Set)		
21	Operate keys and set switches in accordance with Test Chart Test 376.	
22	At signaling test set—main module— Adjust settings for 11 pulses per second at 44 percent break.	
23	Operate GEN SUPV key to ON HK.	
24	At signaling test set—loop interface unit— Set FUNCTION switch to SR.	
25	At test set (register)— Set L switch to OFF.	
26	Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
27	At test set (register)— Key A, B, C digits in accordance with Test Chart (refer to paragraph 3.01).	
28	At signaling test set—main module— Operate GEN SUPV key to OFF HK.	
29	At test set (register)— Depress and hold key in accordance with DEPRESS AND HOLD column on Test Chart.	
30	At signaling test set—main module— Momentarily operate keyset * key.	
31	Momentarily operate keyset 1 key.	WAIT TO DIAL lamp lighted. At test set (register)— Dial tone silenced. At MTF— Trouble record taken.

STEP	ACTION	VERIFICATION
		A_, B_, C_ digits designations perforated. D_, E_, F_, G_ digit designations perforated corresponding to key held in Step 29.
32	At signaling test set—main module— Operate OPERATE-CLEAR key to CLEAR.	OPERATE-CLEAR lamp extinguished. WAIT TO DIAL lamp extinguished.
33	At test set (register)— Momentarily operate RL key.	All lamps extinguished.
34	Repeat Steps 21 through 33, as required for Tests 377 through 379.	
35	Restore all keys and switches and remove all patching cords not required in next test.	
AR. CCSA Call—Prefix Digit 8		
15	Operate keys and set switches in accordance with Test Chart Test 380.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. LT and digits dialed designations perforated.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 381 through 383.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
AS. Interchangeable Codes and/or NPA-411 Information Codes		
13	Operate keys and set switches in accordance with Test Chart Test 384.	
14	Insert make-busy plug into ORMB_ jack associated with register under test.	
15	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.

SECTION 218-135-503

STEP	ACTION	VERIFICATION
16	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken (refer to Table A).
17	Momentarily operate RL key.	All lamps extinguished.
18	Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
19	At register frame— Block nonoperated OVL relay.	
20	At test set— Dial 1, A_ through H_ digits for Test 386 (refer to paragraph 3.01); start timing.	Dial tone silenced.
21	In 10 seconds— Dial J_, K_ digits.	Trouble record taken. LT1, FAC designations perforated.
22	Momentarily operate RL key.	All lamps extinguished.
23	At register frame— Remove blocking tool from OVL relay.	
24	Repeat Steps 13 through 23, as required for Tests 385 through 388.	
25	At MTF— Remove make-busy plug from ORMB_ jack.	
26	Restore all keys and switches and remove all patching cords not required in next test.	

TABLE A

TEST NO.	TIME INTERVAL BEFORE TROUBLE RECORD TAKEN	TROUBLE RECORDER CARD PERFORATIONS
384	3 to 4 Seconds	LT1, OR
385	3 to 4 Seconds	X11, FAC
386	—	LT1, FAC
387	—	LT, OR

AT. C_ Digit Translation

13 Operate keys and set switches in accordance with Test Chart Test 388.

STEP	ACTION	VERIFICATION
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
15	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. For Test 388— FAC, X11 designations perforated. For Test 389— FAC, LT1 designations perforated.
16	Momentarily operate RL key.	All lamps extinguished.
17	Repeat Steps 13 through 16, as required for Test 389.	
18	Restore all keys and switches and remove all patching cords not required in next test.	

AU. Range Extension for Unigauge Cabling

15	Operate keys and set switches in accordance with Test Chart Test 390.	
16	At test set— Momentarily operate STT key.	For Tests 390 and 392— Dial tone heard. At MTF— AS lamp lighted. For Tests 391 and 393— Dial tone <i>not</i> heard. At MTF— AS lamp <i>not</i> lighted.
17	At test set— Momentarily operate RL key.	All lamps extinguished.
18	Repeat Steps 15 through 17, as required for Tests 391 through 393.	
19	Restore all keys and switches and remove all patching cords not required in next test.	

AV. Unused Frequency Combinations

13	Operate keys and set switches in accordance with Test Chart Test 394.	
14	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.

SECTION 218-135-503

STEP	ACTION	VERIFICATION
15	At test set— Key digits in accordance with Test Chart (refer to paragraph 3.01).	
16	Momentarily operate RL key.	Overflow tone silenced. All lamps extinguished.
17	Repeat Steps 13 through 16, as required for Test 395.	
18	Restore all keys and switches and remove all patching cords not required in next test.	
AW. B_ Digit Translation		
15	Operate keys and set switches in accordance with Test Chart Test 396.	
16	At test Set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. PK, SCK, and digits dialed designations perforated. If digit 0, 1, or 8 was prefixed to number dialed— LT2, LT1, or LT3 designations perforated, respectively.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 397 through 409.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
AX. CCSA Call—Access Digit 8		
15	Operate keys and set switches in accordance with Test Chart Test 410.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. LT3 designation perforated.

STEP	ACTION	VERIFICATION
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Test 411.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
AY. Toll Diversion		
24	Operate keys and set switches in accordance with Test Chart Test 412.	
25	At MTF— Operate VMT1, T1 REV keys.	
26	At test set— Momentarily operate STT key.	Dial tone heard At MTF— As lamp lighted
27	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. No trouble record taken. Voltmeter reading of approximately 105-volts when register was seized and during outpulsing from test set and a momentary increase to 120-volts at end of pulsing from test set indicates correct tip and ring polarity.
		Note: If the tip and ring are reversed, voltmeter reading will be 120-volts on seizure and outpulsing and 105-volts at end of pulsing.
28	Momentarily operate RL key.	All lamps extinguished.
29	Repeat Steps 24 through 28, as required for Test 413.	
30	Restore all keys and switches and remove all patching cords not required in next test.	
AZ. Wideband Service		
15	Operate keys and set switches in accordance with Test Chart Test 414.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. For Test 414—

SECTION 218-135-503

STEP	ACTION	VERIFICATION
		PK and keyed digits designations perforated. For Test 415— PK1 and keyed digits designations perforated. For Tests 416, 417— Overflow tone heard.
18	Momentarily operate RL key.	All lamps extinguished. For Tests 416, 417— Overflow tone silenced.
19	Repeat Steps 15 through 18, as required for Tests 415 through 417.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
BA. No Coin Present		
15	Operate keys and set switches in accordance with Test Chart Test 418.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— AS lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to 3.01).	Dial tone silenced. Trouble record taken. SCN and keyed digits designations perforated.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18, as required for Tests 419 through 421.	
20	Restore all keys and switches and remove all patching cords not required in next test.	
BB. Lead Tests Between Originating Registers and Completing Markers		
15	Operate keys and set switches in accordance with Test Chart Test 422.	
16	At the master test control circuit (MTC)— Ground (7T) of MFC1 relay.	KCH relay operates.
17	In office without the AMRST— In <i>each</i> completing marker block non-operated the RTST relay, or in office with the AMRST— At the AMRST frame— Insulate (5-6T) of DOR1 relay.	Either action will cause a trouble record to be taken on any outgoing OR test call.

STEP	ACTION	VERIFICATION
18	At test set— Momentarily operate SST relay.	Dial tone heard. At MTF— AS lamp lighted.
19	At test set— Dial digits shown on test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble Record taken. PK, SCK, number dialed, class of service, RP if ring party, TP if tip party designations perforated. For tests 422 through 426— LT designation perforated. For tests 425 and 431— OBS designation perforated. For tests 428 through 432— FAC, LT designation perforated. For test 427 and 433— FAC, LT3 designations perforated.
20	Momentarily operate RL key.	All lamps extinguished.
21	Repeat Steps 15 through 20, as required for Tests 423 through 433.	
22	Remove all applied ground cords, insulating and blocking tools, patching cords, and restore all keys and switches.	
BC. ♦Digit 8 Access Call to Enhanced Private Communications System (EPSCS) No. 1 ESS		
15	Operate keys and set switches in accordance with Test Chart Test 434.	
16	At test set— Momentarily operate STT key.	Dial tone heard. At MTF— As lamp lighted.
17	At test set— Dial digits shown on Test Chart (refer to paragraph 3.01).	Dial tone silenced. Trouble record taken. A4, 7; LT3 designations perforated.
18	Momentarily operate RL key.	All lamps extinguished.
19	Repeat Steps 15 through 18 as required for Test 435.	
20	Restore all keys and switches and remove all patching cords not required in next test.♦	

5. PREPARATION OF TEST CHART

5.01 The Test Chart is used as a particular number chart and provides the priming information required for each test. Information obtained from local office records should be used to fill in the Test Chart in the following manner:

- (a) Record the required class of service in the CLASS OF SERVICE columns. Do not use a manual or CCSA class of service unless specified.
- (b) When office is arranged for rate treatment, record the required rate treatment in the RATE TREATMENT column.
- (c) When required to simulate a tip-party ground, record the CN key in the MTF MISCELLANEOUS KEYS AND/OR SWITCHES column.
- (d) *For Coin Class*

TYPE OF REGISTER	RECORD CN KEY OF TRUNK TEST CKT IN MISC COLUMN OF MTF	RECORD CN KEY OF TEST SET IN MISC COLUMN OF TEST SET
Coin First — Grd Start	✓	✓
Coin First — Loop Start	✓	
Dial-Tone-First — Loop Start	✓	
Dial-Tone-First — Loop Start and Coin First — Grd Start	✓	✓

When coin service improvement (dial-tone-first) is provided, record CN, DTNF keys in the MTF MISCELLANEOUS KEYS AND/OR SWITCHES column.

- (e) When centrex class of service is selected, record prefix digit 9 in PREFIX DIGIT column.
- (f) Record the A through F digits, as required for NPA and/or office codes in the DIAL OR KEY DIGITS ON TEST SET (CALLED

NUMBER) columns. The selection of codes should be made so that each usable numerical is employed for each dialable or TOUCH-TONE digit. When selecting an office code for a 7-digit call do not select a 0, 1, or any numerical that will be recognized as a code or treated as an unused digit for the B_ digit.

- (g) When dial pulse calling, record dial speed loop condition under associated PULSING CONT columns.
- (h) When TOUCH-TONE calling, record PB, RP keys in TEST SET MISC KEYS columns.

5.02 Test A

- (1) For Tests 5, 6, 13, and 14, apply (a), (b), (c), and (f) of paragraph 5.01 using a centrex class of service.
- (2) For Tests 7, 8, 15, 16, 19, and 25, apply (a), (d), and (f) of paragraph 5.01 using a coin class of service.
- (3) For all other Tests, apply (a) through (f) of paragraph 5.01, as required using various classes of service.

5.03 Test B

- (1) Apply (a) and (d) of paragraph 5.01 using a coin class of service other than manual.
- (2) Record the A through C digits, as required for a free call in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.04 Test C

- For Tests 34 and 35, apply (a) through (d) of paragraph 5.01, as required using a noncentrex class of service.

5.05 Test D

- For Tests 36 and 37, apply (a), (b), (d), and (g) or (h) of paragraph 5.01, as required using a coin or noncoin manual class of service.

5.06 Test E

- For Tests 38 through 41, apply (a), (b), (c), and (f) of paragraph 5.01, as required for a foreign area code using a noncoin class of service.

5.07 Test F

- (1) For Tests 42 and 44, apply (a), (b), and (c) of paragraph 5.01, as required using a centrex class of service.
- (2) For Tests 43 and 45, apply (a), (b), and (c) of paragraph 5.01, as required using a centrex class of service.
- (3) For Tests 42 through 45, record the A digit, as required for a 11X service code in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) column.

5.08 Test G

- (1) For Tests 46 through 51, apply (a) through (d) of paragraph 5.01, as required using various classes of service.
- (2) For Tests 46 and 49, record the A digit, as required for a X11 service code in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) column.
- (3) For Tests 48 and 51, record the A through C digits, as required for an assigned NPA code in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) column.

5.09 Test H

- (1) For Tests 52, 54, 55 and 57, apply (a), (c), and (f) of paragraph 5.01 using a noncentrex class of service.
- (2) For Tests 53 and 56, apply (a), (b), (c), and (f) of paragraph 5.01 using a centrex class of service.

5.10 Test I

- (1) For Tests 58 and 60, apply (a) and (b) of paragraph 5.01, as required using a noncoin class of service.
- (2) For Test 59, apply (a) and (d) of paragraph 5.01 using a coin class of service.

- (3) For Test 60, record the A through F digits, as required for an assigned NPA and office code in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

- (4) For Test 61, apply (a) and (b) of paragraph 5.01 using a centrex class of service.

5.11 Test J

- (1) For Test 62 apply (a) and (d) of paragraph 5.01 using a coin class of service other than manual as required for coin-first service.
- (2) For Test 63 apply (a) and (d) of paragraph 5.01 using a coin class of service other than manual as required for dial-tone-first coin service (earlier version).
- (3) For Test 63, record the A through G digits, as required for an assigned office code and number in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.12 Test K

- For Tests 64 through 67, apply (a), (b), and (g) of paragraph 5.01 using a 2-party class of service requiring party test.

5.13 Test L

- Apply (a), (b), (e), and (g) or (h) of paragraph 5.01, as required using a class of service and rate treatment for reversal of tip and ring leads for centrex attendant trunks or tie lines.

5.14 Test M

- (1) For Test 69 and 72, apply (a) and (d) of paragraph 5.01 using a coin class of service.
- (2) For Tests 70 and 73, apply (a) and (b) of paragraph 5.01 using a noncoin class of service.
- (3) For Tests 71 and 74, apply (a) and (b) of paragraph 5.01 using a centrex class of service.

5.15 Test N

SECTION 218-135-503

(1) For Tests 75, 77, 78, and 80, apply (a), (b), and (f) of paragraph 5.01 using a noncoin class of service.

(2) For Tests 76 and 79, apply (a), (b), and (f) of paragraph 5.01 using a centrex class of service.

5.16 Test N.1

(1) For Tests 81 through 100, apply (a) and (b) of paragraph 5.01 using a class of service having access to the IDDD route selected.

(2) Record country codes and national numbers, as required in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns as follows:

(a) For Tests 82, 83, 84, 90, 91, and 92, record the A through J digits for country codes and national numbers, when the register is arranged for time for additional digits after 7, 8, or 9 digits.

(b) For Tests 85 through 88 and 93 through 96, record the A through M digits for country codes and national numbers, when the register is arranged for marker start after 9, 10, 11, or 12 digits.

(c) For Tests 97 through 100, record the A through L digits for country codes and national numbers, when the register is arranged to require an end-of-dial signal after 8, 9, 10, or 11 digits or recognize an end-of-dial signal after the register has begun timing for additional digits.

5.17 Test N.2

(1) For Tests 101 through 135, apply (a) and (b) of paragraph 5.01 using a class of service having access to the IDDD route selected.

(2) Record country codes and national numbers, as required in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns as follows:

(a) For Tests 101 through 106 and 114 through 119, record the A, B, and C digits for country codes, when the register is arranged

to record the maximum number of digits (11 or 12 digits).

(b) For Tests 107, 108, 109, 120, 121, and 122, record the A through J digits for country codes and national numbers, when the register is arranged to time for additional digits after 7, 8, or 9 digits.

(c) For Tests 110 through 113 and 123 through 126, record the A through J digits for country codes and national numbers, when the register is arranged for marker start after 9, 10, 11, or 12 digits.

(d) For Tests 127 through 130, record the A through L digits for country codes and national numbers, when the register is arranged to require an end-of-dial signal after 8, 9, 10, or 11 digits or recognize an end-of-dial signal after the register has begun timing for additional digits.

5.18 Test O

(1) For Tests 147, 153, 156, and 157, apply (a) and (b) of paragraph 5.01 using a centrex class of service.

(2) For all other Tests, apply (a) of paragraph 5.01 using a class of service having access to the route selected.

(3) Record miscellaneous codes and any additional digits, as required in the DIAL OR KEY DIGITS TEST SET (CALLED NUMBER) columns as follows:

(a) For Tests 136 through 141, record all unused A digits and any additional digits required for the register to engage a marker.

(b) For Tests 142 through 147, 154, and 157, record all unused A digits and any additional digits required for the register to engage the marker for 1X-type codes.

(c) For Tests 148 through 153, 155, and 156, record all used A digits and any additional digits required for the register to engage the marker for 11- and 11X-type codes.

5.19 Test P

- (1) For Tests 169, 175, 178, and 179, apply (a) and (b) of paragraph 5.01 using a centrex class of service.
- (2) For all other Tests apply (a) of paragraph 5.01 using a class of service having access to route selected.
- (3) Record miscellaneous codes and any additional digits, as required in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns as follows:

- (a) For Tests 158 through 163, record unused A digits and/or used A digits and unused B digits and any additional digits required for the register to engage the marker.
- (b) For Tests 164 through 169, 176, and 178, record all used A and B digits and any additional digits required for the register to engage the marker for 1XX--type codes.
- (c) For Tests 170 through 175, 177, and 179, record all used A and B digits and any additional digits required for the register to engage the marker for 11- and 11XX-type codes.

5.20 Test Q

- (1) For Tests 180 through 219 and 224 through 236 apply (a) through (d) of paragraph 5.01 using various classes of service.
- (2) For Tests 220 through 223 and 227 apply (a) through (c) of paragraph 5.01 using a class of service having access to the CCSA network.
- (3) Record NPA codes, office codes, miscellaneous codes, and any additional digits, as required in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns as follows:
 - (a) For Tests 180 through 186, record the A and B or A, B, and C digits for assigned noninterchangeable local office codes required for the register to engage the pretranslator and any additional digits required for the register to engage the marker.
 - (b) For Test 188, record the A, B, and C digits for an assigned NPA code required for the register to engage the pretranslator.

(c) For Tests 189 through 199, record the A or A and B digits for 1X- or 1XX type codes required for the register to engage the pretranslator and any additional digits required for the register to engage the marker.

(d) For Tests 200 through 208, record the A or A and B digits for 11X- or 11XX-type codes required for the register to engage the pretranslator and any additional digits required for the register to engage the marker.

(e) For Tests 209 through 223, and 230 through 237, record the A and C, A and B, or A, B, and C digits for assigned NON-, N1N-, and NN0-type NPA and/or office codes required for the register to engage the pretranslator and any additional digits required for the register to engage the marker.

Note: When the register is arranged for interchangeable codes, record the A, B, and C digits for an interchangeable area code for Tests 210, 214, 220, 230, and 231.

(f) For Test 224, record the A, B, and C digits for a 11 foreign area directing code required for the register to engage the pretranslator and any additional digits required for the register to engage the marker.

(g) For Tests 225 and 227, record the A, B, and C digits for a vacant code required for the register to engage the pretranslator and any additional digits required for the register to engage the marker.

(h) For Tests 226 and 228, record the A, B, and C digits for an assigned noninterchangeable office code required for the register to engage the pretranslator and any additional digits required for the register to engage the marker.

(i) For Tests 229 record the A, B, and C digits for an assigned noninterchangeable NPA code required for the register to engage the pretranslator and any additional digits required for the register to engage the marker.

5.21 Test Q.1

SECTION 218-135-503

(1) For Tests 238 through 254, apply (a) and (b) of paragraph 5.01 using a class of service having access to the IDDD route selected.

(2) When an end-of-dial signal is required, record KP in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) column and 4W in the TEST SET MISC KEYS column.

(3) Record country codes and national numbers as required, in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns as follows:

(a) For Tests 238, 239, and 240, record the A through L digits for country codes and national numbers as required, when the pretranslator indicates to the register to engage a marker after 9 or 10 digits.

(b) For Tests 241, 242, and 243, record the A through J digits for country codes and national numbers as required, when the pretranslator indicates to the register to time for additional digits after 7, 8, or 9 digits.

(c) For Test 244, record the A, B, and C digits for a vacant code required for the register to engage the pretranslator.

(d) For Tests 245 through 254, record the A through M for country codes and national numbers and required, when the pretranslator indicates to the register to engage a marker after 9, 10, 11, or 12 digits.

5.22 Test R

- Apply (a) and (d) of paragraph 5.01 using a coin class of service.

5.23 Test S

(1) Apply (a) and (b) of paragraph 5.01 using a class of service having access to a manual office.

(2) Record the A through C digits as required for a code to a manual office in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.24 Test T

(1) For Tests 257, apply (a), (d), and (g) or (h) of paragraph 5.01 using a coin class of service.

(2) For Test 258, apply (a), (b), and (g) or (h) of paragraph 5.01 using a noncoin class of service.

5.25 Test U

(1) For Test 259, apply (a) and (b) of paragraph 5.01 using a noncoin class of service.

(2) For Test 260, apply (a) and (d) of paragraph 5.01 using a coin class of service.

(3) For Test 261, apply (a) and (b) of paragraph 5.01 using a centrex class of service.

(4) For Test 261, record the A and B digits as required for repetitive digit timing for 11X special PBX and tie line codes in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

(5) For Tests 262 through 267, apply (a) and (b) of paragraph 5.01 using a class of service having access to the IDDD route selected.

(6) For Tests 262 through 267, record A through L digits, as required for partial digits for country code and national number in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.26 Test V

- Apply (a), (b), and (f) of paragraph 5.01 using a noncoin class of service.

5.27 Test W

- No Test Chart preparation required.

5.28 Test X

(1) For Test 269, apply (a), (b), and (g) or (h) of paragraph 5.01 using a noncoin class of service.

(2) For Test 269, record the A digit using any numeral other than 0, 1, 8, or 9 and the B and C digits using any numeral in the DIAL

OR KEY DIGITS ON TEST SET (CALLED NUMBER) column.

(3) For Test 270, apply (a), (b), and (g) or (h) of paragraph 5.01 using a class of service having access to the IDDD route selected.

(4) For Test 270, record the A through M digits, as required for country codes and national numbers in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.29 Test Y

- Apply (a), (d), and (f) of paragraph 5.01 using a coin class of service other than manual.

5.30 Test Z

- Apply (a), (b), and (g) or (h) of paragraph 5.01 using a noncoin class of service.

5.31 Test AA

- (1) For Test 273, apply (a), (b), and (f) of paragraph 5.01 using a noncoin class of service.
- (2) For Test 274, apply (a), (b), and (f) of paragraph 5.01 using a coin class of service.

5.32 Test AB

- (1) For Test 275, 276, 277, and 279, apply (a) of paragraph 5.01 using a centrex class of service.

5.33 Test AC

- (1) For Tests 280 through 287, apply (a) through (e) and (g) of paragraph 5.01, as required using classes of services to operate each equipped class of service tens and units register relay.
- (2) For Tests 288 through 292, apply (a) through (e) of paragraph 5.01, as required using classes of services to operate each equipped class of service tens and units register relay.

5.34 Test AD

(1) For Tests 293 through 298, apply (a) and (b) of paragraph 5.01 using a noncoin class of service.

(2) Record numerals 9, 8, or 7 for each A through C digit in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns. If for example, the numerals 999 are recorded for the A through C digits, determine from office records whether these numerals are translated as a local office code or a vacant code. If translation indicates a local office code, then the numeral 9 shall also be recorded for the D through G digits. However, if translation indicates a vacant code, only the numerals for the A through C digits are recorded.

5.35 Test AD.1

(1) For Tests 299 through 304, apply (a) and (b) of paragraph 5.01 using a noncoin class of service.

(2) Record numerals 9, 8, or 7 for each A through C digit in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns. If for example, the numerals 999 are recorded for the A through C digits, determine from office records whether these numerals are translated as a local office code or a vacant code. If translation indicates a local office code, then the numeral 9 shall also be recorded for the D through G digits. However, if translation indicates a vacant code, only the numerals for the A through C digits are recorded.

5.36 Test AE

- For Tests 305 and 306, apply (a), (b), and (g) or (h) of paragraph 5.01 using a centrex class of service.

5.37 Test AF

(1) For Tests 307 and 308, apply (a), (b), and (g) or (h) of paragraph 5.01 using a centrex class of service.

(2) Record the A digit for a 11X signal service code in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.38 Test AG

SECTION 218-135-503

- Apply (a), (b), and (g) or (h) of paragraph 5.01 using a centrex class of service.

5.39 Test AH

- (1) For Tests 310 through 19, apply (a), (b), (e), and (g) or (h) of paragraph 5.01 using a centrex class of service.
- (2) For Tests 320 through 323, apply (a) and (b) of paragraph 5.01 using a centrex class of service.
- (3) Record 1XX special codes and any additional digits, as required in the DIAL OR KEY DIGITS TEST SET (CALLED NUMBER) columns as follows:
 - (a) For Test 310, record the A and B digits for an assigned 1XX special code, using a "1" for the A digit (if provided) and any additional digits required to start repetitive digit timing.
 - (b) For Tests 311 through 316, record the A and B digits for assigned 1XX special codes, using a "1" for the A digit (if provided) and any additional digits required by an A-digit translator and when a timing interval is *not* required for an additional digit.
 - (c) For Tests 317 through 319, record the A and B digits for assigned 1XX special codes, using a "1" for the A digit (if provided) and any additional digits required by an A-digit translator and when a timing interval is required for an additional digit.

5.40 Test AJ

- For Tests 324 and 325, apply (a) through (c), (e) and (f) as required using a noncoin class of service.

5.41 Test AK

- For Tests 326 and 327, apply (a) through (c), (e) and (f) of paragraph 5.01, as required using a noncoin class of service.

5.42 Test AL

- For Tests 328 through 335, apply (a) through (c), (e) and (f) of paragraph 5.01, as required using a noncoin class of service.

5.43 Test AM

- For Tests 336 through 339, apply (a) through (c), (e) and (F) of paragraph 5.01, as required using a noncoin class of service.

5.44 Test AN

- (1) For Tests 340 through 343, apply (a) through (c), and (e) of paragraph 5.01 using a noncoin class of service.
- (2) Record the A through C digits, as required for assigned office codes in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.45 Test AN.1

- (1) For Tests 344 through 347, apply (a) through (c), and (e) of paragraph 5.01 using a noncoin class of service.
- (2) Record the A through C digits, as required for assigned office codes in the DIAL OR KEY DIGITS ON TEST SET ((CALLED NUMBER) columns.

5.46 Test AO

- (1) For Tests 348 through 351, apply (a) through (c), and (e) of paragraph 5.01 using a noncoin class of service.
- (2) Record the A through C digits, as required for assigned office codes in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.47 Test AO.1

- (1) For Tests 352 through 355, apply (a) through (c), and (e) of paragraph 5.01 using a noncoin class of service.
- (2) Record the A through C digits, as required for assigned office codes in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.48 Test AP

- (1) For Tests 356 through 363, apply (a) through (c), and (e) of paragraph 5.01 using a noncoin class of service.
- (2) Record the A through C digits, as required for assigned office codes in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.49 Test AP.1

- (1) For Tests 364 through 371, apply (a) through (c), and (e) of paragraph 5.01 using a noncoin class of service.
- (2) Record the A through C digits, as required for assigned office codes in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.50 Test AQ

- (1) For Tests 372 through 375, apply (a) through (c), and (e) of paragraph 5.01 using a noncoin class of service.
- (2) Record the A through C digits, as required for assigned codes in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.51 Test AQ.1

- (1) For Tests 376 through 379, apply (a) through (c), and (e) of paragraph 5.01 using a noncoin class of service.
- (2) Record the A through C digits, as required for assigned office codes in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.52 Test AR

- For Tests 380 through 383, apply (a), (c), (e), and (f), as required using a class of service having access to the CCSA network.

5.53 Test AS

- For Tests 384 through 387, apply (a), (b), (c), (e), (f), and (g) or (h) of paragraph 5.01

using interchangeable codes and a noncoin class of service.

5.54 Test AT

- (1) For Tests 388 and 389, apply (a), (b), (c), (e), and (g) or (h) of paragraph 5.01 using a noncoin class of service.
- (2) Record the A and B digits for an assigned NN0 code and any additional digits, as required in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.55 Test AU

- (1) For Tests 390 through 393, apply (a) through (f) of paragraph 5.01 using a noncoin class of service.
- (2) For Tests 390 and 392, record the line location of a line arranged for range extension for unigauge cabling in the LINE LOCATION columns.
- (3) For Tests 391 and 393, record the line location of a line *not* arranged for range extension for unigauge cabling in the LINE LOCATION columns.

5.56 Test AV

- For Tests 394 and 395, apply (a) of paragraph 5.01 using a noncoin class of service.

5.57 Test AW

- (1) For Tests 396 through 401 and 403 through 408, apply (a), (c), and (d) of paragraph 5.01 as required using a noncentrex class of service.
- (2) For Tests 402 and 409, apply (a) and (b) of paragraph 5.01 using a centrex class of service.
- (3) For Tests 396 and 403 record the A, B, and C digits of an assigned office code in the DIAL OR KEY DIGITS TEST SET (CALLED NUMBER) columns.
- (4) For Tests 397, 398, 404, and 405, record the A and C digits of an assigned office code or interchangeable code in the DIAL OR

KEY DIGITS TEST SET (CALLED NUMBER) columns.

(5) For Tests 399 and 406, record the A through F digits of an assigned NPA and office code in the DIAL OR KEY DIGITS TEST SET (CALLED NUMBER) columns.

(6) For Tests 400, 401, 402, 407, 408, and 409, record the A and C, D through F digits of an assigned NPA or interchangeable code and an office code in the DIAL OR KEY DIGITS TEST SET (CALLED NUMBER) columns.

5.58 Test AX

(1) For Tests 410 and 411, apply (a) and (b) of paragraph 5.01 using a class of service having access to the CCSA network.

(2) For Test 410, record the A through C digits for an assigned office code for the route of the CCSA network in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

(3) For Test 411, record the A through F digits for an assigned NPA and office code for the route of the CCSA network in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.59 Test AY

(1) For Tests 412 and 413, apply (a), (b), and (g) or (h) of paragraph 5.01 using a class of service requiring toll diversion for certain codes.

(2) For Test 412, record the A through C digits for an assigned office code for the route requiring toll diversion in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

(3) For Test 413, record the A through F digits for an assigned NPA and office codes for

the route requiring toll diversion in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.60 Test AZ

(1) For Test 414, record the line location of a PBX trunk arranged for wideband service in the LINE LOCATION columns.

(2) For Tests 414 through 417, record the A through C digits, as required for an assigned wideband office code in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

(3) For Tests 415 through 417, apply (a) and (b) of paragraph 5.01 using a wideband class of service.

5.61 Test BA

(1) For Tests 418 through 421 apply (a) and (d) of paragraph 5.01 using a coin class of service as required for coin service improvement (DTF).

(2) For Tests 418 and 419, record the A through C digits, as required for an assigned office code in the DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER) columns.

5.62 Test BB

(1) For Tests 422 through 433 apply (a) through (f) of paragraph 5.01, as required using various classes of service.

5.63 Test BC

(1) For tests 434 and 435 apply (a) and (b) of paragraph 5.01 using a class of service having access to EPSCS No. 1 ESS.

TEST CHART

TEST	TEST TITLE	TEST NO.	MASTER TEST FRAME PRIMING INFORMATION													TEST SET													PRECISION PULSE GENERATOR	TEST NO.	TEST						
			LINE LOCATION				CLASS OF SERVICE		RATE TREAT.		FREQ CONT (TOUCH-TONE CALLING)		DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER)					DE-PRESS AND HOLD KEY	PULSING CONT		MISC KEYS		PULSING SPEED	% BREAK													
			FRAME NO.		VERT GR		HOR GR	VERT FILE	TENS		UNITS		FCA	FCB	PREFIX DIGITS	A	B		C	D					E	F	G	H				J	K	L	M	SPEED	LOOP COND
			TENS	UNITS	TENS	UNITS			TENS	UNITS	TENS	UNITS																									
J	Abandoned Call	62																																		62	J
	During Coin Test		63																													63					
K	Two-Party Test	64																													64	K					
			Ring	65																															65		
			Tip	66																															66		
				67																															67		
L	Start Pulse Signal	68																													68	L					
M	Zero Operator	69																													69	M					
			Dial Pulse	Coin	70																														70		
				Noncoin	71																														71		
				Centrex	72																														72		
				TOUCH-TONE	73																														73		
N	Prefix Digit 0+	75																													75	N					
			Dial Pulse	Coin	76																														76		
				Noncoin	77																														77		
				Centrex	78																														78		
				TOUCH-TONE	79																														79		
N.1	Prefix Digits 01+	81																													81	N.1					
			Dial Pulse	82																															82		
				83																															83		
				84																															84		
				85																															85		
				86																															86		
				87																															87		
				88																															88		
				TOUCH-TONE	89																														89		
			90																														90				
			91																														91				
			92																														92				
			93																														93				
			94																														94				

TEST CHART

TEST	TEST TITLE	TEST NO.	MASTER TEST FRAME PRIMING INFORMATION												TEST SET														PRECISION PULSE GENERATOR		TEST NO.	TEST								
			LINE LOCATION						CLASS OF SERVICE		RATE TREAT.		FREQ CONT (TOUCH-TONE CALLING)		DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER)														MISC KEYS	PULSING SPEED			% BREAK							
			FRAME NO.		VERT GR		HOR GR	VERT FILE	TENS	UNITS	TENS	UNITS	FCA	FCB	NTC	PREFIX DIGITS	A	B	C	D	E	F	G	H	J	K	L	M						DE-PRESS AND HOLD KEY	PULSING CONT					
			TENS	UNITS	TENS	UNITS																							PPS DIAL	LOOP COND L SWITCH										
AC (Cont)	Dial Pulse TOUCH-TONE	283	3*	3*	0	3	3	3																												283	AC			
		284	4*	4*	0	4*	4	4																												284	(Cont)			
		285	5*	5*	0	5*	5	0																												285				
		286	0	6*	0	6*	6	1																												286				
		287	1*	7*	0	7*	7	2																													287			
		288	2*	8*	0	8*	8	3																													288			
		289	3*	9*	0	9*	9	4																													289			
		290	4*	0	1*	0	0	0																													290			
		291	5*	1	1*	1	1	1																													291			
		292	0	2*	0	2	2	2																													292			
AD	Precision Pulsing Tests (3A Pulse Generating Test Set)	293																																		293	AD			
		294																																			294			
		295																																			295			
		296																																				296		
		297																																				297		
		298																																					298	
		299																																				299	AD.1	
AD.1	Precision Pulsing Tests (4A Signaling Test Set)	300																																			300			
		301																																			301			
		302																																				302		
		303																																				303		
		304																																				304		
AE	Intracentrex Call	305																																			305	AE		
		306																																				306		
AF	11X Special Codes (Nonservice Codes) — Originating Register Equipped for Centrex Service Only	307																																			307	AF		
		308																																				308		
AG	Zero Operator Calls for Centrex Service	309																																			309	AG		
AH	1XX Special Codes for Centrex Service	310																																			310	AH		
		311																																			311			
		312																																				312		
		313																																				313		
		314																																				314		

* If not equipped use 0.
 † If office is equipped with both wire-spring-relay and non-wire-spring-relay type dial pulse originating registers and all incoming dial pulse registers in the office are wire-spring-relay type, use L switch setting 9.
 ‡ A_ through C_ or A_ through G_ digits generated by 3A pulsing test set.
 § A_ through C_ or A_ through G_ digits generated by 4A signaling test set.

L	M	DE-PRESS AND HOLD KEY	PULSING CONT		MISC KEYS			PRECISION PULSE GENERATOR		TEST NO.	TEST
			SPEED	LOOP COND				PULSING SPEED	% BREAK		
			PPS DIAL	L SWITCH							
										315	AH (Cont)
										316	
										317	
										318	
										319	
					PB	RP	4W			320	
					PB	RP	4W			321	
					PB	RP	4W			322	
					PB	RP	4W			323	
					PB	RP				324	AJ
					PB	RP				325	
					PB	RP				326	AK
					PB	RP				327	
					PB	RP				328	AL
					PB	RP				329	
					PB	RP				330	
					PB	RP				331	
					PB	RP				332	
					PB	RP				333	
					PB	RP				334	
					PB	RP				335	
					PB	RP				336	AM
					PB	RP				337	
					PB	RP				338	
					PB	RP				339	
		3			PB	RP				340	AN
		5			PB	RP				341	
		7			PB	RP				342	
		0			PB	RP				343	
		3			PB	RP				344	AN.1
		5			PB	RP				345	
		7			PB	RP				346	
		0			PB	RP				347	

Test Chart (Cont)

TEST CHART

TEST	TEST TITLE	TEST NO.	MASTER TEST FRAME PRIMING INFORMATION												TEST SET													TEST NO.	TEST													
			LINE LOCATION				CLASS OF SERVICE		RATE TREAT.		FREQ CONT (TOUCH-TONE CALLING)		DIAL OR KEY DIGITS ON TEST SET (CALLED NUMBER)												PULSING CONT		PRECISION PULSE GENERATOR															
			FRAME NO.		VERT GR		HOR GR	VERT FILE	TENS		UNITS		FCA	FCB	PREFIX DIGITS	A	B	C	D	E	F	G	H	J	K	L	M			DE-PRESS AND HOLD KEY	SPEED	LOOP COND	MISC KEYS		PULSING SPEED	% BREAK						
			TENS	UNITS	TENS	UNITS			TENS	UNITS	TENS	UNITS																					PPS DIAL	L SWITCH			PB	RP				
AR	CCSA Call — Prefix Digit 8	Dial Pulse TOUCH-TONE	380																															380	AR							
			381																																	381						
			382																																		382					
			383																																		383					
AS	Interchangeable Codes and/or NPA-411 Information Codes		384																																	384	AS					
			385																																		385					
			386																																			386				
			387																																			387				
AT	C-Digit Translation		388																																	388	AT					
			389																																		389					
AU	Range Extension for Unigauge Cabling	Dial Pulse TOUCH-TONE	390																																		390	AU				
			391																																			391				
			392																																				392			
			393																																				393			
AV	Unused Frequency Combinations		394																																		394	AV				
			395																																			395				
AW	B-Digit Translation	Dial Pulse TOUCH-TONE	396																																			396	AW			
			397																																				397			
			398																																					398		
			399																																					399		
			400																																					400		
			401																																					401		
			402																																					402		
			403																																						403	
			404																																						404	
			405																																						405	
			406																																						406	
407																																						407				
408																																						408				
409																																						409				
AX	CSSA Call — Access Digit 8	Dial Pulse TOUCH-TONE	410																																			410	AX			
			411																																				411			

